



## DLP6500FYE 数字微镜器件 (DMD)

### 1 特性

- 高分辨率 WQXGA (1920x1080) 阵列，微镜数超过 2 百万
  - 0.65 英寸微镜阵列对角线
  - 7.56 $\mu$ m 微镜间距
  - $\pm 12^\circ$  微镜倾斜角（相对于平面）
  - 2.5 $\mu$ s 微镜交叉时间
  - 设计用于边缘照明
- 设计用于宽频带可见光 (420nm – 700nm)
  - 窗口传输 97%（单通、通过双窗面）
  - 微镜反射率 88%
  - 阵列衍射效率 86%
  - 阵列填充因子 92%
- 两条 16 位低压差分信号 (LVDS)、双倍数据速率 (DDR) 输入数据总线
- 专用 DLPC900 控制器，支持 9500Hz（1 位二进制）和 250Hz（8 位灰度）高速模式速率
- 高达 400MHz 的输入数据时钟速率
- 集成微镜驱动器电路

### 2 应用

- 工业
  - 针对机器视觉和质量控制的 3D 扫描仪
  - 3D 打印
  - 直接成像平版印刷术
  - 激光打标和修复
- 医疗
  - 眼科
  - 针对四肢和皮肤测量的 3D 扫描仪
  - 高光谱成像
  - 高光谱扫描
- 显示屏
  - 3D 成像显微镜
  - 智能和自适应照明

### 3 说明

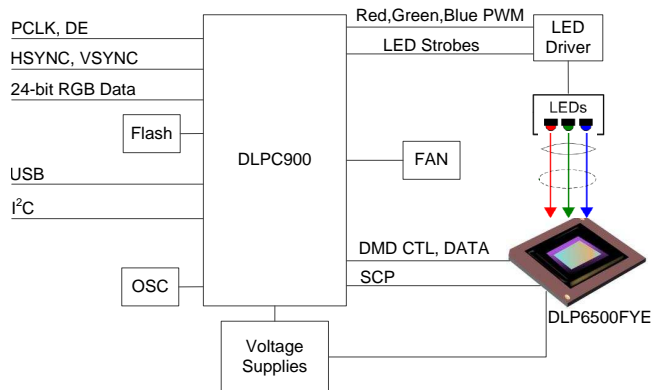
高分辨率 0.65 1080p 数字微镜器件 (DMD) 是一款可调制入射光幅度、方向和/或位相的空间照明调制器 (SLM)，微镜数达 2 百万以上。DLP6500FYE 具有独特的功能，非常适用于广泛的工业、医疗和高级成像应用。DLP6500FYE 需要与 DLPC900 数字控制器结合使用才能实现可靠功能和操作。此专用芯片组可在高速条件下提供全高清 (HD) 分辨率，并且能够轻松集成到多种终端设备解决方案中。

#### 器件信息<sup>(1)</sup>

| 器件型号    | 封装        | 封装尺寸（标称值）             |
|---------|-----------|-----------------------|
| DLP6500 | FYE (350) | 40.6mm × 31.8mm × 6mm |

(1) 如需了解所有可用封装，请见数据表末尾的可订购产品附录。

#### 简化图表



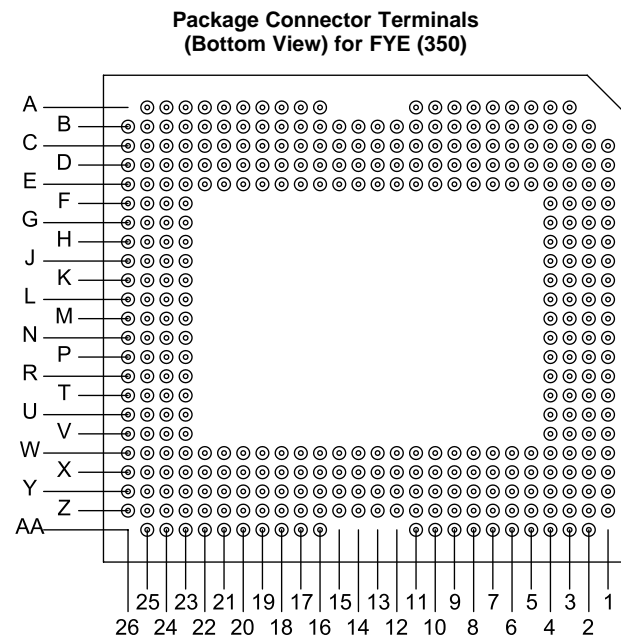
## 目录

|          |  |           |             |  |           |
|----------|--|-----------|-------------|--|-----------|
| <b>1</b> | <b>特性</b>                                  | <b>1</b>  | <b>7.4</b>  | <b>Device Functional Modes</b>                     | <b>29</b> |
| <b>2</b> | <b>应用</b>                                  | <b>1</b>  | <b>7.5</b>  | <b>Window Characteristics and Optics</b>           | <b>29</b> |
| <b>3</b> | <b>说明</b>                                  | <b>1</b>  | <b>7.6</b>  | <b>Micromirror Array Temperature Calculation</b>   | <b>30</b> |
| <b>4</b> | <b>修订历史记录</b>                              | <b>2</b>  | <b>7.7</b>  | <b>Micromirror Landed-on/Landed-Off Duty Cycle</b> | <b>31</b> |
| <b>5</b> | <b>Pin Configuration and Functions</b>     | <b>3</b>  | <b>8</b>    | <b>Application and Implementation</b>              | <b>34</b> |
| <b>6</b> | <b>Specifications</b>                      | <b>10</b> | <b>8.1</b>  | <b>Application Information</b>                     | <b>34</b> |
| 6.1      | Absolute Maximum Ratings                   | 10        | <b>8.2</b>  | <b>Typical Application</b>                         | <b>34</b> |
| 6.2      | Handling Ratings                           | 11        | <b>9</b>    | <b>Power Supply Recommendations</b>                | <b>35</b> |
| 6.3      | Recommended Operating Conditions           | 11        | <b>9.1</b>  | <b>DMD Power Supply Requirements</b>               | <b>35</b> |
| 6.4      | Thermal Information                        | 13        | <b>9.2</b>  | <b>DMD Power Supply Power-Up Procedure</b>         | <b>35</b> |
| 6.5      | Electrical Characteristics                 | 14        | <b>9.3</b>  | <b>DMD Power Supply Power-Down Procedure</b>       | <b>35</b> |
| 6.6      | Timing Requirements                        | 15        | <b>10</b>   | <b>Layout</b>                                      | <b>38</b> |
| 6.7      | Typical Characteristics                    | 19        | <b>10.1</b> | <b>Layout Guidelines</b>                           | <b>38</b> |
| 6.8      | System Mounting Interface Loads            | 20        | <b>10.2</b> | <b>Layout Example</b>                              | <b>38</b> |
| 6.9      | Micromirror Array Physical Characteristics | 21        | <b>11</b>   | <b>器件文档支持</b>                                      | <b>43</b> |
| 6.10     | Micromirror Array Optical Characteristics  | 22        | <b>11.1</b> | <b>器件支持</b>  | <b>43</b> |
| 6.11     | Window Characteristics                     | 23        | <b>11.2</b> | <b>文档支持</b>  | <b>44</b> |
| 6.12     | Chipset Component Usage Specification      | 23        | <b>11.3</b> | <b>商标</b>  | <b>44</b> |
| <b>7</b> | <b>Detailed Description</b>                | <b>24</b> | <b>11.4</b> | <b>静电放电警告</b>                                      | <b>44</b> |
| 7.1      | Overview                                   | 24        | <b>11.5</b> | <b>术语表</b>   | <b>44</b> |
| 7.2      | Functional Block Diagram                   | 25        | <b>12</b>   | <b>机械封装和可订购信息</b>                                  | <b>44</b> |
| 7.3      | Feature Description                        | 26        |             |  |           |

## 4 修订历史记录

| 日期          | 修订版本 | 注释    |
|-------------|------|-------|
| 2014 年 10 月 | *    | 最初发布。 |

## 5 Pin Configuration and Functions



**Table 1. Pin Functions**

| PIN <sup>(1)</sup> |     | TYPE<br>(I/O/P) | SIGNAL | DATA<br>RATE <sup>(2)</sup> | INTERNAL<br>TERM <sup>(3)</sup> | DESCRIPTION    | TRACE<br>(mils) <sup>(4)</sup> |
|--------------------|-----|-----------------|--------|-----------------------------|---------------------------------|----------------|--------------------------------|
| NAME               | NO. |                 |        |                             |                                 |                |                                |
| DATA BUS A         |     |                 |        |                             |                                 |                |                                |
| D_AN(0)            | B14 | Input           | LVDS   | DDR                         | Differential                    | Data, Negative | 494.88                         |
| D_AN(1)            | B15 | Input           | LVDS   | DDR                         | Differential                    | Data, Negative | 486.18                         |
| D_AN(2)            | C16 | Input           | LVDS   | DDR                         | Differential                    | Data, Negative | 495.16                         |
| D_AN(3)            | K24 | Input           | LVDS   | DDR                         | Differential                    | Data, Negative | 485.67                         |
| D_AN(4)            | B18 | Input           | LVDS   | DDR                         | Differential                    | Data, Negative | 494.76                         |
| D_AN(5)            | L24 | Input           | LVDS   | DDR                         | Differential                    | Data, Negative | 490.63                         |
| D_AN(6)            | C19 | Input           | LVDS   | DDR                         | Differential                    | Data, Negative | 495.16                         |
| D_AN(7)            | H24 | Input           | LVDS   | DDR                         | Differential                    | Data, Negative | 485.55                         |
| D_AN(8)            | H23 | Input           | LVDS   | DDR                         | Differential                    | Data, Negative | 495.16                         |
| D_AN(9)            | B25 | Input           | LVDS   | DDR                         | Differential                    | Data, Negative | 485.59                         |
| D_AN(10)           | D24 | Input           | LVDS   | DDR                         | Differential                    | Data, Negative | 495.16                         |
| D_AN(11)           | E25 | Input           | LVDS   | DDR                         | Differential                    | Data, Negative | 495.16                         |
| D_AN(12)           | F25 | Input           | LVDS   | DDR                         | Differential                    | Data, Negative | 490.04                         |
| D_AN(13)           | H25 | Input           | LVDS   | DDR                         | Differential                    | Data, Negative | 485.91                         |
| D_AN(14)           | L25 | Input           | LVDS   | DDR                         | Differential                    | Data, Negative | 495.16                         |
| D_AN(15)           | G24 | Input           | LVDS   | DDR                         | Differential                    | Data, Negative | 495.16                         |
| D_AP(0)            | C14 | Input           | LVDS   | DDR                         | Differential                    | Data, Positive | 494.84                         |
| D_AP(1)            | B16 | Input           | LVDS   | DDR                         | Differential                    | Data, Positive | 486.22                         |
| D_AP(2)            | C17 | Input           | LVDS   | DDR                         | Differential                    | Data, Positive | 494.65                         |
| D_AP(3)            | K23 | Input           | LVDS   | DDR                         | Differential                    | Data, Positive | 488.42                         |
| D_AP(4)            | B19 | Input           | LVDS   | DDR                         | Differential                    | Data, Positive | 495.16                         |
| D_AP(5)            | L23 | Input           | LVDS   | DDR                         | Differential                    | Data, Positive | 490.67                         |
| D_AP(6)            | C20 | Input           | LVDS   | DDR                         | Differential                    | Data, Positive | 498.11                         |
| D_AP(7)            | J24 | Input           | LVDS   | DDR                         | Differential                    | Data, Positive | 486.22                         |
| D_AP(8)            | J23 | Input           | LVDS   | DDR                         | Differential                    | Data, Positive | 495.47                         |
| D_AP(9)            | C25 | Input           | LVDS   | DDR                         | Differential                    | Data, Positive | 485.94                         |
| D_AP(10)           | E24 | Input           | LVDS   | DDR                         | Differential                    | Data, Positive | 495.16                         |
| D_AP(11)           | D25 | Input           | LVDS   | DDR                         | Differential                    | Data, Positive | 494.13                         |
| D_AP(12)           | G25 | Input           | LVDS   | DDR                         | Differential                    | Data, Positive | 488.98                         |
| D_AP(13)           | J25 | Input           | LVDS   | DDR                         | Differential                    | Data, Positive | 492.56                         |
| D_AP(14)           | K25 | Input           | LVDS   | DDR                         | Differential                    | Data, Positive | 495.16                         |
| D_AP(15)           | F24 | Input           | LVDS   | DDR                         | Differential                    | Data, Positive | 495.16                         |
| DATA BUS B         |     |                 |        |                             |                                 |                |                                |
| D_BN(0)            | Z14 | Input           | LVDS   | DDR                         | Differential                    | Data, Negative | 494.92                         |
| D_BN(1)            | Z15 | Input           | LVDS   | DDR                         | Differential                    | Data, Negative | 486.18                         |
| D_BN(2)            | Y16 | Input           | LVDS   | DDR                         | Differential                    | Data, Negative | 496.46                         |
| D_BN(3)            | P24 | Input           | LVDS   | DDR                         | Differential                    | Data, Negative | 493.74                         |
| D_BN(4)            | Z18 | Input           | LVDS   | DDR                         | Differential                    | Data, Negative | 494.76                         |
| D_BN(5)            | N24 | Input           | LVDS   | DDR                         | Differential                    | Data, Negative | 495.16                         |
| D_BN(6)            | Y19 | Input           | LVDS   | DDR                         | Differential                    | Data, Negative | 492.16                         |
| D_BN(7)            | T24 | Input           | LVDS   | DDR                         | Differential                    | Data, Negative | 492.68                         |

- The following power supplies are required to operate the DMD: VCC, VCCI, VOFFSET, VBIAS, and VRESET. VSS must also be connected.
- DDR = Double Data Rate.  
SDR = Single Data Rate.  
Refer to the [Timing Requirements](#) for specifications and relationships.
- Internal term = CMOS level internal termination. Refer to [Recommended Operating Conditions](#) for differential termination specification.
- Dielectric Constant for the DMD Type A ceramic package is approximately 9.6.  
For the package trace lengths shown:  
Propagation Speed =  $11.8 / \sqrt{9.6} = 3.808$  in/ns.  
Propagation Delay =  $0.262$  ns/in =  $262$  ps/in =  $10.315$  ps/mm.

**Table 1. Pin Functions (continued)**

| PIN <sup>(1)</sup>                      |     | TYPE<br>(I/O/P) | SIGNAL  | DATA<br>RATE <sup>(2)</sup> | INTERNAL<br>TERM <sup>(3)</sup> | DESCRIPTION                                  | TRACE<br>(mils) <sup>(4)</sup> |
|---|-----|-----------------|---------|-----------------------------|---------------------------------|--|--------------------------------|
| NAME                                    | NO. |                 |         |                             |                                 |  |                                |
| D_BN(8)                                 | T23 | Input           | LVDS    | DDR                         | Differential                    | Data, Negative                               | 484.45                         |
| D_BN(9)                                 | Z25 | Input           | LVDS    | DDR                         | Differential                    | Data, Negative                               | 492.09                         |
| D_BN(10)                                | X24 | Input           | LVDS    | DDR                         | Differential                    | Data, Negative                               | 497.72                         |
| D_BN(11)                                | W25 | Input           | LVDS    | DDR                         | Differential                    | Data, Negative                               | 495.16                         |
| D_BN(12)                                | V25 | Input           | LVDS    | DDR                         | Differential                    | Data, Negative                               | 484.17                         |
| D_BN(13)                                | T25 | Input           | LVDS    | DDR                         | Differential                    | Data, Negative                               | 481.42                         |
| D_BN(14)                                | N25 | Input           | LVDS    | DDR                         | Differential                    | Data, Negative                               | 495.16                         |
| D_BN(15)                                | U24 | Input           | LVDS    | DDR                         | Differential                    | Data, Negative                               | 489.8                          |
| D_BP(0)                                 | Y14 | Input           | LVDS    | DDR                         | Differential                    | Data, Positive                               | 494.88                         |
| D_BP(1)                                 | Z16 | Input           | LVDS    | DDR                         | Differential                    | Data, Positive                               | 486.26                         |
| D_BP(2)                                 | Y17 | Input           | LVDS    | DDR                         | Differential                    | Data, Positive                               | 495.16                         |
| D_BP(3)                                 | P23 | Input           | LVDS    | DDR                         | Differential                    | Data, Positive                               | 492.48                         |
| D_BP(4)                                 | Z19 | Input           | LVDS    | DDR                         | Differential                    | Data, Positive                               | 495.16                         |
| D_BP(5)                                 | N23 | Input           | LVDS    | DDR                         | Differential                    | Data, Positive                               | 497.99                         |
| D_BP(6)                                 | Y20 | Input           | LVDS    | DDR                         | Differential                    | Data, Positive                               | 495.16                         |
| D_BP(7)                                 | R24 | Input           | LVDS    | DDR                         | Differential                    | Data, Positive                               | 492.05                         |
| D_BP(8)                                 | R23 | Input           | LVDS    | DDR                         | Differential                    | Data, Positive                               | 484.45                         |
| D_BP(9)                                 | Y25 | Input           | LVDS    | DDR                         | Differential                    | Data, Positive                               | 492.24                         |
| D_BP(10)                                | W24 | Input           | LVDS    | DDR                         | Differential                    | Data, Positive                               | 495.16                         |
| D_BP(11)                                | X25 | Input           | LVDS    | DDR                         | Differential                    | Data, Positive                               | 494.72                         |
| D_BP(12)                                | U25 | Input           | LVDS    | DDR                         | Differential                    | Data, Positive                               | 483.78                         |
| D_BP(13)                                | R25 | Input           | LVDS    | DDR                         | Differential                    | Data, Positive                               | 489.13                         |
| D_BP(14)                                | P25 | Input           | LVDS    | DDR                         | Differential                    | Data, Positive                               | 499.53                         |
| D_BP(15)                                | V24 | Input           | LVDS    | DDR                         | Differential                    | Data, Positive                               | 488.66                         |
| <b>SERIAL CONTROL</b>                   |     |                 |         |                             |                                 |  |                                |
| SCTRL_AN                                | C23 | Input           | LVDS    | DDR                         | Differential                    | Serial Control, Negative                     | 492.95                         |
| SCTRL_BN                                | Y23 | Input           | LVDS    | DDR                         | Differential                    | Serial Control, Negative                     | 493.78                         |
| SCTRL_AP                                | C24 | Input           | LVDS    | DDR                         | Differential                    | Serial Control, Positive                     | 493.78                         |
| SCTRL_BP                                | Y24 | Input           | LVDS    | DDR                         | Differential                    | Serial Control, Positive                     | 493.11                         |
| <b>CLOCKS</b>                           |     |                 |         |                             |                                 |  |                                |
| DCLK_AN                                 | B23 | Input           | LVDS    |                             | Differential                    | Clock, Negative                              | 480.35                         |
| DCLK_BN                                 | Z23 | Input           | LVDS    |                             | Differential                    | Clock, Negative                              | 486.22                         |
| DCLK_AP                                 | B22 | Input           | LVDS    |                             | Differential                    | Clock, Positive                              | 485.83                         |
| DCLK_BP                                 | Z22 | Input           | LVDS    |                             | Differential                    | Clock, Positive                              | 491.93                         |
| <b>SERIAL COMMUNICATIONS PORT (SCP)</b> |     |                 |         |                             |                                 |  |                                |
| SCP_DO                                  | B8  | Output          | LVC MOS | SDR                         |                                 | Serial Communications Port Output            |                                |
| SCP_DI                                  | B7  | Input           | LVC MOS | SDR                         | Pull-Down                       | Serial Communications Port Data Input        |                                |
| SCP_CLK                                 | B6  | Input           | LVC MOS |                             | Pull-Down                       | Serial Communications Port Clock             |                                |
| SCP_ENZ                                 | C8  | Input           | LVC MOS |                             | Pull-Down                       | Active-low Serial Communications Port Enable |                                |
| <b>MICROMIRROR RESET CONTROL</b>        |     |                 |         |                             |                                 |  |                                |
| RESET_ADDR(0)                           | X9  | Input           | LVC MOS |                             | Pull-Down                       | Reset Driver Address Select                  |                                |
| RESET_ADDR(1)                           | X8  | Input           | LVC MOS |                             | Pull-Down                       | Reset Driver Address Select                  |                                |
| RESET_ADDR(2)                           | Z8  | Input           | LVC MOS |                             | Pull-Down                       | Reset Driver Address Select                  |                                |
| RESET_ADDR(3)                           | Z7  | Input           | LVC MOS |                             | Pull-Down                       | Reset Driver Address Select                  |                                |
| RESET_MODE(0)                           | W11 | Input           | LVC MOS |                             | Pull-Down                       | Reset Driver Mode Select                     |                                |
| RESET_MODE(1)                           | Z10 | Input           | LVC MOS |                             | Pull-Down                       | Reset Driver Mode Select                     |                                |
| RESET_SEL(0)                            | Y10 | Input           | LVC MOS |                             | Pull-Down                       | Reset Driver Level Select                    |                                |
| RESET_SEL(1)                            | Y9  | Input           | LVC MOS |                             | Pull-Down                       | Reset Driver Level Select                    |                                |

**Table 1. Pin Functions (continued)**

| PIN <sup>(1)</sup>                  |     | TYPE<br>(I/O/P) | SIGNAL  | DATA<br>RATE <sup>(2)</sup> | INTERNAL<br>TERM <sup>(3)</sup> | DESCRIPTION  | TRACE<br>(mils) <sup>(4)</sup> |
|-------------------------------------|-----|-----------------|---------|-----------------------------|---------------------------------|--|--------------------------------|
| NAME                                | NO. |                 |         |                             |                                 |  |                                |
| RESET_STROBE                        | Y7  | Input           | LVC MOS |                             | Pull-Down                       | Reset Address, Mode, & Level latched on rising-edge    |                                |
| <b>ENABLES and INTERRUPTS</b>       |     |                 |         |                             |                                 |  |                                |
| PWRDNZ                              | D2  | Input           | LVC MOS |                             | Pull-Down                       | Active-low Device Reset                                |                                |
| RESET_OEZ                           | W7  | Input           | LVC MOS |                             | Pull-Down                       | Active-low output enable for DMD reset driver circuits |                                |
| RESETZ                              | Z6  | Input           | LVC MOS |                             | Pull-Down                       | Active-low sets Reset circuits in known VOFFSET state  |                                |
| RESET_IRQZ                          | Z5  | Output          | LVC MOS |                             |                                 | Active-low, output interrupt to ASIC                   |                                |
| <b>VOLTAGE REGULATOR MONITORING</b> |     |                 |         |                             |                                 |  |                                |
| PG_BIAS                             | E11 | Input           | LVC MOS |                             | Pull-Up                         | Active-low fault from external VBIAS regulator         |                                |
| PG_OFFSET                           | B10 | Input           | LVC MOS |                             | Pull-Up                         | Active-low fault from external VOFFSET regulator       |                                |
| PG_RESET                            | D11 | Input           | LVC MOS |                             | Pull-Up                         | Active-low fault from external VRESET regulator        |                                |
| EN_BIAS                             | D9  | Output          | LVC MOS |                             |                                 | Active-high enable for external VBIAS regulator        |                                |
| EN_OFFSET                           | C9  | Output          | LVC MOS |                             |                                 | Active-high enable for external VOFFSET regulator      |                                |
| EN_RESET                            | E9  | Output          | LVC MOS |                             |                                 | Active-high enable for external VRESET regulator       |                                |
| <b>LEAVE PIN UNCONNECTED</b>        |     |                 |         |                             |                                 |  |                                |
| MBRST(0)                            | C2  | Output          | Analog  |                             | Pull-Down                       | For proper DMD operation, do not connect               |                                |
| MBRST(1)                            | C3  | Output          | Analog  |                             | Pull-Down                       | For proper DMD operation, do not connect               |                                |
| MBRST(2)                            | C5  | Output          | Analog  |                             | Pull-Down                       | For proper DMD operation, do not connect               |                                |
| MBRST(3)                            | C4  | Output          | Analog  |                             | Pull-Down                       | For proper DMD operation, do not connect               |                                |
| MBRST(4)                            | E5  | Output          | Analog  |                             | Pull-Down                       | For proper DMD operation, do not connect               |                                |
| MBRST(5)                            | E4  | Output          | Analog  |                             | Pull-Down                       | For proper DMD operation, do not connect               |                                |
| MBRST(6)                            | E3  | Output          | Analog  |                             | Pull-Down                       | For proper DMD operation, do not connect               |                                |
| MBRST(7)                            | G4  | Output          | Analog  |                             | Pull-Down                       | For proper DMD operation, do not connect               |                                |
| MBRST(8)                            | G3  | Output          | Analog  |                             | Pull-Down                       | For proper DMD operation, do not connect               |                                |
| MBRST(9)                            | G2  | Output          | Analog  |                             | Pull-Down                       | For proper DMD operation, do not connect               |                                |
| MBRST(10)                           | J4  | Output          | Analog  |                             | Pull-Down                       | For proper DMD operation, do not connect               |                                |
| MBRST(11)                           | J3  | Output          | Analog  |                             | Pull-Down                       | For proper DMD operation, do not connect               |                                |
| MBRST(12)                           | J2  | Output          | Analog  |                             | Pull-Down                       | For proper DMD operation, do not connect               |                                |
| MBRST(13)                           | L4  | Output          | Analog  |                             | Pull-Down                       | For proper DMD operation, do not connect               |                                |
| MBRST(14)                           | L3  | Output          | Analog  |                             | Pull-Down                       | For proper DMD operation, do not connect               |                                |
| MBRST(15)                           | L2  | Output          | Analog  |                             | Pull-Down                       | For proper DMD operation, do not connect               |                                |

**Table 1. Pin Functions (continued)**

| PIN <sup>(1)</sup>    |     | TYPE<br>(I/O/P) | SIGNAL | DATA<br>RATE <sup>(2)</sup> | INTERNAL<br>TERM <sup>(3)</sup> | DESCRIPTION                              | TRACE<br>(mils) <sup>(4)</sup> |
|-----------------------|-----|-----------------|--------|-----------------------------|---------------------------------|--|--------------------------------|
| NAME                  | NO. |                 |        |                             |                                 |  |                                |
| LEAVE PIN UNCONNECTED |     |                 |        |                             |                                 |  |                                |
| RESERVED_PFE          | E7  | Input           | LVCMOS |                             | Pull-Down                       | For proper DMD operation, do not connect |                                |
| RESERVED_TM           | D13 | Input           | LVCMOS |                             | Pull-Down                       | For proper DMD operation, do not connect |                                |
| RESERVED_XI1          | E13 | Input           | LVCMOS |                             | Pull-Down                       | For proper DMD operation, do not connect |                                |
| RESERVED_TP0          | W12 | Input           | Analog |                             |                                 | For proper DMD operation, do not connect |                                |
| RESERVED_TP1          | Y11 | Input           | Analog |                             |                                 | For proper DMD operation, do not connect |                                |
| RESERVED_TP2          | X11 | Input           | Analog |                             |                                 | For proper DMD operation, do not connect |                                |
| LEAVE PIN UNCONNECTED |     |                 |        |                             |                                 |  |                                |
| RESERVED_BA           | Y12 | Output          | LVCMOS |                             |                                 | For proper DMD operation, do not connect |                                |
| RESERVED_BB           | C12 | Output          | LVCMOS |                             |                                 | For proper DMD operation, do not connect |                                |
| RESERVED_TS           | D5  | Output          | LVCMOS |                             |                                 | For proper DMD operation, do not connect |                                |
| LEAVE PIN UNCONNECTED |     |                 |        |                             |                                 |  |                                |
| NO CONNECT            | B11 |                 |        |                             |                                 | For proper DMD operation, do not connect |                                |
| NO CONNECT            | C11 |                 |        |                             |                                 | For proper DMD operation, do not connect |                                |
| NO CONNECT            | C13 |                 |        |                             |                                 | For proper DMD operation, do not connect |                                |
| NO CONNECT            | E12 |                 |        |                             |                                 | For proper DMD operation, do not connect |                                |
| NO CONNECT            | E14 |                 |        |                             |                                 | For proper DMD operation, do not connect |                                |
| NO CONNECT            | E23 |                 |        |                             |                                 | For proper DMD operation, do not connect |                                |
| NO CONNECT            | H4  |                 |        |                             |                                 | For proper DMD operation, do not connect |                                |
| NO CONNECT            | N2  |                 |        |                             |                                 | For proper DMD operation, do not connect |                                |
| NO CONNECT            | N3  |                 |        |                             |                                 | For proper DMD operation, do not connect |                                |
| NO CONNECT            | N4  |                 |        |                             |                                 | For proper DMD operation, do not connect |                                |
| NO CONNECT            | R2  |                 |        |                             |                                 | For proper DMD operation, do not connect |                                |
| NO CONNECT            | R3  |                 |        |                             |                                 | For proper DMD operation, do not connect |                                |
| NO CONNECT            | R4  |                 |        |                             |                                 | For proper DMD operation, do not connect |                                |
| NO CONNECT            | T4  |                 |        |                             |                                 | For proper DMD operation, do not connect |                                |
| NO CONNECT            | U2  |                 |        |                             |                                 | For proper DMD operation, do not connect |                                |
| NO CONNECT            | U3  |                 |        |                             |                                 | For proper DMD operation, do not connect |                                |
| NO CONNECT            | U4  |                 |        |                             |                                 | For proper DMD operation, do not connect |                                |
| NO CONNECT            | W3  |                 |        |                             |                                 | For proper DMD operation, do not connect |                                |
| NO CONNECT            | W4  |                 |        |                             |                                 | For proper DMD operation, do not connect |                                |

**Table 1. Pin Functions (continued)**

| PIN <sup>(1)</sup> |     | TYPE<br>(I/O/P) | SIGNAL | DATA<br>RATE <sup>(2)</sup> | INTERNAL<br>TERM <sup>(3)</sup> | DESCRIPTION                              | TRACE<br>(mils) <sup>(4)</sup> |
|--------------------|-----|-----------------|--------|-----------------------------|---------------------------------|--|--------------------------------|
| NAME               | NO. |                 |        |                             |                                 |  |                                |
| NO CONNECT         | W5  |                 |        |                             |                                 | For proper DMD operation, do not connect |                                |
| NO CONNECT         | W13 |                 |        |                             |                                 | For proper DMD operation, do not connect |                                |
| NO CONNECT         | W14 |                 |        |                             |                                 | For proper DMD operation, do not connect |                                |
| NO CONNECT         | W23 |                 |        |                             |                                 | For proper DMD operation, do not connect |                                |
| NO CONNECT         | X4  |                 |        |                             |                                 | For proper DMD operation, do not connect |                                |
| NO CONNECT         | X5  |                 |        |                             |                                 | For proper DMD operation, do not connect |                                |
| NO CONNECT         | X13 |                 |        |                             |                                 | For proper DMD operation, do not connect |                                |
| NO CONNECT         | Y2  |                 |        |                             |                                 | For proper DMD operation, do not connect |                                |
| NO CONNECT         | Y3  |                 |        |                             |                                 | For proper DMD operation, do not connect |                                |
| NO CONNECT         | Y4  |                 |        |                             |                                 | For proper DMD operation, do not connect |                                |
| NO CONNECT         | Y5  |                 |        |                             |                                 | For proper DMD operation, do not connect |                                |
| NO CONNECT         | Z11 |                 |        |                             |                                 | For proper DMD operation, do not connect |                                |

| PIN                 |     |     |      | TYPE<br>(I/O/P) | SIGNAL | DESCRIPTION  |
|---------------------|-----|-----|------|-----------------|--------|--|
| NAME <sup>(1)</sup> | NO. | NO. | NO.  |                 |        |  |
| VBIAS               | A6  | A7  | A8   | Power           | Analog | Supply voltage for positive Bias level of Micromirror reset signal.  |
| VBIAS               | AA6 | AA7 | AA8  | Power           | Analog | Supply voltage for positive Bias level of Micromirror reset signal.  |
| VOFFSET             | A3  | A4  | A25  | Power           | Analog | Supply voltage for HVCMOS logic.   |
| VOFFSET             | B26 | L26 | M26  | Power           | Analog | Supply voltage for stepped high voltage at Micromirror address electrodes.   |
| VOFFSET             | N26 | Z26 | Z27  | Power           | Analog | Supply voltage for Offset level of MBRST(31:0).  |
| VOFFSET             | AA3 | AA4 | AA25 | Power           | Analog |  |
| VRESET              | G1  | H1  | J1   | Power           | Analog | Supply voltage for negative Reset level of Micromirror reset signal.   |
| VRESET              | R1  | T1  | U1   | Power           | Analog | Supply voltage for negative Reset level of Micromirror reset signal.   |
| VCC                 | A9  | B3  | B5   | Power           | Analog | Supply voltage for LVCMOS core logic.<br>Supply voltage for normal high level at Micromirror address electrodes.<br>Supply voltage for positive Offset level of Micromirror reset signal during Power Down sequence. |
| VCC                 | B12 | C1  | C6   | Power           | Analog |  |
| VCC                 | C10 | D4  | D6   | Power           | Analog |  |
| VCC                 | D8  | E1  | E2   | Power           | Analog |  |
| VCC                 | E10 | E15 | E16  | Power           | Analog |  |
| VCC                 | E17 | F3  | H2   | Power           | Analog |  |
| VCC                 | K1  | K3  | M4   | Power           | Analog |  |
| VCC                 | P1  | P3  | T2   | Power           | Analog |  |
| VCC                 | V3  | W1  | W2   | Power           | Analog |  |
| VCC                 | W6  | W9  | W10  | Power           | Analog |  |
| VCC                 | W15 | W16 | W17  | Power           | Analog |  |
| VCC                 | X3  | X6  |      | Power           | Analog |  |
| VCC                 | Y1  | Y8  | Y13  | Power           | Analog |  |
| VCC                 | Z1  | Z3  | Z12  | Power           | Analog |  |
| VCC                 | AA2 | AA9 | AA10 | Power           | Analog |  |
| VCCI                | A16 | A17 | A18  | Power           | Analog | Supply voltage for LVDS receivers.   |

(1) The following power supplies are required to operate the DMD: VCC, VCCI, VOFFSET, VBIAS, and VRESET. VSS must also be connected.



| NAME <sup>(1)</sup> | PIN  |      |      | TYPE<br>(I/O/P) | SIGNAL | DESCRIPTION                                 |
|---------------------|------|------|------|-----------------|--------|---|
|                     | NO.  | NO.  | NO.  |                 |        |   |
| VCCI                | A20  | A21  | A23  | Power           | Analog | Supply voltage for LVDS receivers.          |
| VCCI                | AA16 | AA17 | AA18 | Power           | Analog | Supply voltage for LVDS receivers.          |
| VCCI                | AA20 | AA21 | AA23 | Power           | Analog | Supply voltage for LVDS receivers.          |
| VSS                 | A5   | A10  | A11  | Power           | Analog | Device Ground. Common return for all power. |
| VSS                 | A19  | A22  | A24  | Power           | Analog | Device Ground. Common return for all power. |
| VSS                 | B2   | B4   | B9   | Power           | Analog | Device Ground. Common return for all power. |
| VSS                 | B13  | B17  | B20  | Power           | Analog | Device Ground. Common return for all power. |
| VSS                 | B21  | B24  | C7   | Power           | Analog | Device Ground. Common return for all power. |
| VSS                 | C15  | C18  | C21  | Power           | Analog | Device Ground. Common return for all power. |
| VSS                 | C22  | C26  | D1   | Power           | Analog | Device Ground. Common return for all power. |
| VSS                 | D3   | D7   | D10  | Power           | Analog | Device Ground. Common return for all power. |
| VSS                 | D12  | D14  | D15  | Power           | Analog | Device Ground. Common return for all power. |
| VSS                 | D16  | D17  | D18  | Power           | Analog | Device Ground. Common return for all power. |
| VSS                 | D19  | D20  | D21  | Power           | Analog | Device Ground. Common return for all power. |
| VSS                 | D22  | D23  | D26  | Power           | Analog | Device Ground. Common return for all power. |
| VSS                 | E6   | E8   | E18  | Power           | Analog | Device Ground. Common return for all power. |
| VSS                 | E19  | E20  | E21  | Power           | Analog | Device Ground. Common return for all power. |
| VSS                 | E22  | E26  | F1   | Power           | Analog | Device Ground. Common return for all power. |
| VSS                 | F2   | F4   | F23  | Power           | Analog | Device Ground. Common return for all power. |
| VSS                 | F26  | G23  | G26  | Power           | Analog | Device Ground. Common return for all power. |
| VSS                 | H3   | H26  | J26  | Power           | Analog | Device Ground. Common return for all power. |
| VSS                 | K2   | K4   | K26  | Power           | Analog | Device Ground. Common return for all power. |
| VSS                 | L1   | M1   | M2   | Power           | Analog | Device Ground. Common return for all power. |
| VSS                 | M3   | M23  | M24  | Power           | Analog | Device Ground. Common return for all power. |
| VSS                 | M25  | N1   | P2   | Power           | Analog | Device Ground. Common return for all power. |
| VSS                 | P4   | P26  | R26  | Power           | Analog | Device Ground. Common return for all power. |
| VSS                 | T3   | T26  | U23  | Power           | Analog | Device Ground. Common return for all power. |
| VSS                 | U26  | V1   | V2   | Power           | Analog | Device Ground. Common return for all power. |
| VSS                 | V4   | V23  | V26  | Power           | Analog | Device Ground. Common return for all power. |
| VSS                 | W8   | W18  | W19  | Power           | Analog | Device Ground. Common return for all power. |
| VSS                 | W20  | W21  | W22  | Power           | Analog | Device Ground. Common return for all power. |
| VSS                 | W26  | X1   | X2   | Power           | Analog | Device Ground. Common return for all power. |
| VSS                 | X7   | X10  | X12  | Power           | Analog | Device Ground. Common return for all power. |
| VSS                 | X14  | X15  | X16  | Power           | Analog | Device Ground. Common return for all power. |
| VSS                 | X17  | X18  | X19  | Power           | Analog | Device Ground. Common return for all power. |
| VSS                 | X20  | X21  | X22  | Power           | Analog | Device Ground. Common return for all power. |
| VSS                 | X23  | X26  | Y6   | Power           | Analog | Device Ground. Common return for all power. |
| VSS                 | Y15  | Y18  | Y21  | Power           | Analog | Device Ground. Common return for all power. |
| VSS                 | Y22  | Y26  | Z2   | Power           | Analog | Device Ground. Common return for all power. |
| VSS                 | Z4   | Z9   | Z13  | Power           | Analog | Device Ground. Common return for all power. |
| VSS                 | Z17  | Z20  | Z21  | Power           | Analog | Device Ground. Common return for all power. |
| VSS                 | Z24  | AA5  | AA11 | Power           | Analog | Device Ground. Common return for all power. |
| VSS                 | AA19 | AA22 | AA24 | Power           | Analog | Device Ground. Common return for all power. |

## 6 Specifications

### 6.1 Absolute Maximum Ratings

over operating free-air temperature range (unless otherwise noted) <sup>(1)</sup>

| SUPPLY VOLTAGES    |  | MIN  | MAX         | UNIT |
|--------------------|--|------|-------------|------|
| VCC                | Supply voltage for LVCMOS core logic <sup>(2)</sup>                    | −0.5 | 4           | V    |
| VCCI               | Supply voltage for LVDS receivers <sup>(2)</sup>                       | −0.5 | 4           | V    |
| VOFFSET            | Supply voltage for HVCMOS and micromirror electrode <sup>(2) (3)</sup> | −0.5 | 9           | V    |
| VBIAS              | Supply voltage for micromirror electrode <sup>(2)</sup>                | −0.5 | 17          | V    |
| VRESET             | Supply voltage for micromirror electrode <sup>(2)</sup>                | −11  | 0.5         | V    |
| VCC – VCCI         | Supply voltage delta (absolute value) <sup>(4)</sup>                   |      | 0.3         | V    |
| VBIAS – VOFFSET    | Supply voltage delta (absolute value) <sup>(5)</sup>                   |      | 8.75        | V    |
| INPUT VOLTAGES     |  |      |             |      |
|                    | Input voltage for all other LVCMOS input pins <sup>(2)</sup>           | −0.5 | VCC + 0.15  | V    |
|                    | Input voltage for all other LVDS input pins <sup>(2) (6)</sup>         | −0.5 | VCCI + 0.15 | V    |
| V <sub>ID</sub>    | Input differential voltage (absolute value) <sup>(7)</sup>             |      | 700         | mV   |
| I <sub>ID</sub>    | Input differential current <sup>(7)</sup>                              |      | 7           | mA   |
| CLOCKS             |  |      |             |      |
| f <sub>clock</sub> | Clock frequency for LVDS interface, DCLK_A                             |      | 460         | MHz  |
|                    | Clock frequency for LVDS interface, DCLK_B                             |      | 460         | MHz  |
| ENVIRONMENTAL      |  |      |             |      |
| T <sub>CASE</sub>  | Case temperature: operational <sup>(8) (9)</sup>                       | −20  | 90          | °C   |
|                    | Case temperature: non-operational <sup>(9)</sup>                       | −40  | 90          | °C   |
|                    | Dew Point (Operating and non-Operating)                                |      | 81          | °C   |

- (1) Stresses beyond those listed under *Absolute Maximum Ratings* may cause permanent damage to the device. These are stress ratings only, and functional operation of the device is not implied at these or any other conditions beyond those indicated under *Recommended Operating Conditions*. Exposure above *Recommended Operating Conditions* for extended periods may affect device reliability.
- (2) All voltages are referenced to common ground VSS. Supply voltages VCC, VCCI, VOFFSET, VBIAS, and VRESET are all required for proper DMD operation. VSS must also be connected
- (3) VOFFSET supply transients must fall within specified voltages.
- (4) To prevent excess current, the supply voltage delta |VCCI – VCC| must be less than specified limit.
- (5) To prevent excess current, the supply voltage delta |VBIAS – VOFFSET| must be less than specified limit. Refer to *Power Supply Recommendations* for additional information.
- (6) This maximum LVDS input voltage rating applies when each input of a differential pair is at the same voltage potential.
- (7) LVDS differential inputs must not exceed the specified limit or damage may result to the internal termination resistors
- (8) Exposure of the DMD simultaneously to any combination of the maximum operating conditions for case temperature, differential temperature, or illumination power density (see *Handling Ratings*).
- (9) DMD Temperature is the worst-case of any test point shown in *Figure 15*, or the active array as calculated by the *Micromirror Array Temperature Calculation*.

## 6.2 Handling Ratings

| PARAMETER <sup>(1) (2) (3)</sup> |   |   | MIN | MAX  | UNIT |
|----------------------------------|---|---|-----|------|------|
| T <sub>stg</sub>                 | DMD Storage Temperature                     |   | –40 | 85   | °C   |
|                                  | Long-Term Storage Dew Point <sup>(4)</sup>  |   |     | 24   | °C   |
|                                  | Short-Term Storage Dew Point <sup>(5)</sup> |   |     | 28   | °C   |
| V <sub>(ESD)</sub>               | Electrostatic discharge                     | All pins, human body model (HBM), per ANSI/ESDA/JEDEC JS-001 <sup>(6)</sup> |     | 2000 | V    |

- (1) Handling Ratings are applicable before the DMD is installed in the final product.
- (2) All CMOS devices require proper Electrostatic Discharge (ESD) handling procedures.
- (3) As a best practice, TI recommends storing the DMD in a temperature and humidity controlled environment.
- (4) Long-term is defined as the average over the usable life.
- (5) Short-term is defined as less than the cumulative days over the usable life of the device.
- (6) JEDEC document JEP155 states that 500-V HBM allows safe manufacturing with a standard ESD control process.

## 6.3 Recommended Operating Conditions

over operating free-air temperature range (unless otherwise noted)

|  |  | MIN  | NOM | MAX        | UNIT |
|--|--|------|-----|------------|------|
| <b>SUPPLY VOLTAGES<sup>(1) (2)</sup></b> |  |      |     |            |      |
| VCC                                      | Supply voltage for LVCMOS core logic   | 3.15 | 3.3 | 3.45       | V    |
| VCCI                                     | Supply voltage for LVDS receivers  | 3.15 | 3.3 | 3.45       | V    |
| VOFFSET                                  | Supply voltage for HVCMOS and micromirror electrodes <sup>(2)</sup>          | 8.25 | 8.5 | 8.75       | V    |
| VBIAS                                    | Supply voltage for micromirror electrodes                                    | 15.5 | 16  | 16.5       | V    |
| VRESET                                   | Supply voltage for micromirror electrodes                                    | –9.5 | –10 | –10.5      | V    |
| VCCI–VCC                                 | Supply voltage delta (absolute value) <sup>(3)</sup>                         |      |     | 0.3        | V    |
| VBIAS–VOFFSET                            | Supply voltage delta (absolute value) <sup>(4)</sup>                         |      |     | 8.75       | V    |
| <b>LVCMOS PINS</b>                       |  |      |     |            |      |
| V <sub>IH</sub>                          | High level Input voltage <sup>(5)</sup>                                      | 1.7  | 2.5 | VCC + 0.15 | V    |
| V <sub>IL</sub>                          | Low level Input voltage <sup>(5)</sup>                                       | –0.3 |     | 0.7        | V    |
| I <sub>OH</sub>                          | High level output current at V <sub>OH</sub> = 2.4 V                         |      |     | –20        | mA   |
| I <sub>OL</sub>                          | Low level output current at V <sub>OL</sub> = 0.4 V                          |      |     | 15         | mA   |
| T <sub>PWRDNZ</sub>                      | PWRDNZ pulse width <sup>(6)</sup>  | 10   |     |            | ns   |
| <b>SCP INTERFACE</b>                     |  |      |     |            |      |
| f <sub>clock</sub>                       | SCP clock frequency <sup>(7)</sup>   |      |     | 500        | kHz  |
| t <sub>SCP_SKEW</sub>                    | Time between valid SCPDI and rising edge of SCPCLK <sup>(8)</sup>            | –800 |     | 800        | ns   |
| t <sub>SCP_DELAY</sub>                   | Time between valid SCPDO and rising edge of SCPCLK <sup>(8)</sup>            |      |     | 700        | ns   |
| t <sub>SCP_BYTE_INTERVAL</sub>           | Time between consecutive bytes   | 1    |     |            | μs   |
| t <sub>SCP_NEG_ENZ</sub>                 | Time between falling edge of SCPENZ and the first rising edge of SCPCLK      | 30   |     |            | ns   |
| t <sub>SCP_PW_ENZ</sub>                  | SCPENZ inactive pulse width (high level)                                     | 1    |     |            | μs   |
| t <sub>SCP_OUT_EN</sub>                  | Time required for SCP output buffer to recover after SCPENZ (from tri-state) |      |     | 1.5        | ns   |
| f <sub>clock</sub>                       | SCP circuit clock oscillator frequency <sup>(9)</sup>                        | 9.6  |     | 11.1       | MHz  |

- (1) Supply voltages VCC, VCCI, VOFFSET, VBIAS, and VRESET are all required for proper DMD operation. VSS must also be connected.
- (2) VOFFSET supply transients must fall within specified max voltages.
- (3) To prevent excess current, the supply voltage delta |VCCI – VCC| must be less than specified limit.
- (4) To prevent excess current, the supply voltage delta |VBIAS – VOFFSET| must be less than specified limit. Refer to Power Supply Recommendations for additional information.
- (5) Tester Conditions for V<sub>IH</sub> and V<sub>IL</sub>:  
Frequency = 60MHz. Maximum Rise Time = 2.5 ns at (20% to 80%)  
Frequency = 60MHz. Maximum Fall Time = 2.5 ns at (80% to 20%)
- (6) PWRDNZ input pin resets the SCP and disables the LVDS receivers. PWRDNZ input pin overrides SCPENZ input pin and tri-states the SCPDO output pin.
- (7) The SCP clock is a gated clock. Duty cycle shall be 50% ± 10%. SCP parameter is related to the frequency of DCLK.
- (8) Refer to [Figure 3](#).
- (9) SCP internal oscillator is specified to operate all SCP registers. For all SCP operations, DCLK is required.

## Recommended Operating Conditions (continued)

over operating free-air temperature range (unless otherwise noted)

|                                      |  | MIN | NOM  | MAX                               | UNIT                    |
|--------------------------------------|--|-----|------|-----------------------------------|-------------------------|
| <b>LVDS INTERFACE</b>                |  |     |      |                                   |                         |
| $f_{\text{clock}}$                   | Clock frequency for LVDS interface, DCLK (all channels)                              |     |      | 400                               | MHz                     |
| $ V_{\text{ID}} $                    | Input differential voltage (absolute value) <sup>(10)</sup>                          | 100 | 400  | 600                               | mV                      |
| $V_{\text{CM}}$                      | Common mode <sup>(10)</sup>  |     | 1200 |                                   | mV                      |
| $V_{\text{LVDS}}$                    | LVDS voltage <sup>(10)</sup>   | 0   |      | 2000                              | mV                      |
| $t_{\text{LVDS\_RSTZ}}$              | Time required for LVDS receivers to recover from PWRDNZ                              |     |      | 10                                | ns                      |
| $Z_{\text{IN}}$                      | Internal differential termination resistance   | 95  |      | 105                               | $\Omega$                |
| $Z_{\text{LINE}}$                    | Line differential impedance (PWB/trace)  | 90  | 100  | 110                               | $\Omega$                |
| <b>ENVIRONMENTAL</b> <sup>(11)</sup> |  |     |      |                                   |                         |
| $T_{\text{DMD}}$                     | DMD temperature—operational, long-term <sup>(12) (13) (14)</sup>                     | 0   |      | 40 to 70 <sup>(13)</sup>          | $^{\circ}\text{C}$      |
|                                      | DMD temperature – operational, short-term  | –20 |      | 75                                | $^{\circ}\text{C}$      |
| $T_{\text{WINDOW}}$                  | Window temperature – operational <sup>(15)</sup>                                     |     |      | 90                                | $^{\circ}\text{C}$      |
| $T_{\text{CERAMIC-WINDOW-DELTA}}$    | Delta ceramic-to-window temperature -operational <sup>(15) (16)</sup>                |     |      | 30                                | $^{\circ}\text{C}$      |
|                                      | Long-term dew point (operational, non-operational, long-term)                        |     |      | 24                                | $^{\circ}\text{C}$      |
|                                      | Short-term dew point <sup>(14) (17)</sup> (operational, non-operational, short-term) |     |      | 28                                | $^{\circ}\text{C}$      |
| $\text{ILL}_{\text{UV}}$             | Illumination, wavelength < 420 nm  |     |      | 0.68                              | $\text{mW}/\text{cm}^2$ |
| $\text{ILL}_{\text{VIS}}$            | Illumination, wavelengths between 420 and 700 nm                                     |     |      | Thermally Limited <sup>(18)</sup> | $\text{mW}/\text{cm}^2$ |
| $\text{ILL}_{\text{IR}}$             | Illumination, wavelength > 700 nm  |     |      | 10                                | $\text{mW}/\text{cm}^2$ |

(10) Refer to [Figure 4](#), [Figure 5](#), and [Figure 6](#).

(11) Optimal, long-term performance and optical efficiency of the Digital Micromirror Device (DMD) can be affected by various application parameters, including illumination spectrum, illumination power density, micromirror landed duty-cycle, ambient temperature (storage and operating), DMD temperature, ambient humidity (storage and operating), and power on or off duty cycle. TI recommends that application-specific effects be considered as early as possible in the design cycle.

(12) DMD Temperature is the worst-case of any thermal test point in [Figure 10](#), or the active array as calculated by the [Figure 15](#).

(13) Per [Figure 1](#), the maximum operational case temperature should be derated based on the micromirror landed duty cycle that the DMD experiences in the end application. Refer to [Micromirror Landed-on/Landed-Off Duty Cycle](#) for a definition of micromirror landed duty cycle.

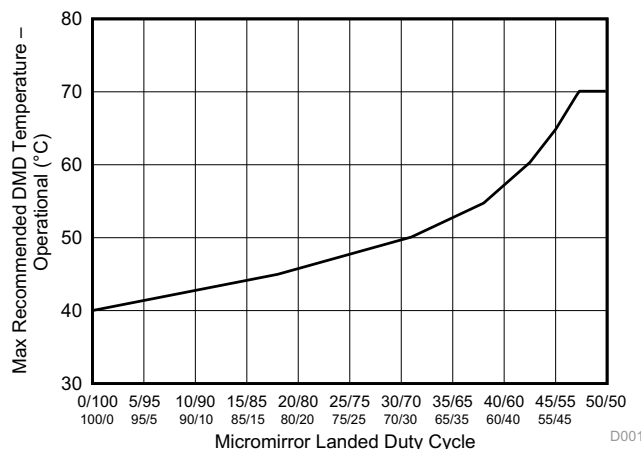
(14) Long-term is defined as the average over the usable life.

(15) Window temperature as measured at thermal test points TP2, TP3, TP4 and TP5 in [Figure 15](#). The locations of thermal test points TP2, TP3, TP4 and TP5 in [Figure 15](#) are intended to measure the highest window edge temperature. If a particular application causes another point on the window edge to be at a higher temperature, a test point should be added to that location.

(16) Ceramic package temperature as measured at test point 1 (TP 1) in [Figure 10](#).

(17) Dew points beyond the specified long-term dew point (operating, non-operating, or storage) are for short-term conditions only, where short-term is defined as < 60 cumulative days over the usable life of the device .

(18) Refer to [Thermal Information](#) and [Micromirror Array Temperature Calculation](#) .



**Figure 1. Max Recommended DMD Temperature – Derating Curve**

## 6.4 Thermal Information

| THERMAL METRIC <sup>(1)</sup>                                 | MIN | DLP6500FYE<br>FYE (350) | MAX | UNIT |
|---|-----|-------------------------|-----|------|
| Active Area-to-Case Ceramic Thermal resistance <sup>(1)</sup> |     |                         | 0.6 | °C/W |

- (1) The DMD is designed to conduct absorbed and dissipated heat to the back of the package where it can be removed by an appropriate heat sink. The heat sink and cooling system must be capable of maintaining the package within the temperature range specified in the [Recommended Operating Conditions](#) . The total heat load on the DMD is largely driven by the incident light absorbed by the active area; although other contributions include light energy absorbed by the window aperture and electrical power dissipation of the array. Optical systems should be designed to minimize the light energy falling outside the window clear aperture since any additional thermal load in this area can significantly degrade the reliability of the device. .

## 6.5 Electrical Characteristics

over operating free-air temperature range (unless otherwise noted)

| PARAMETER           | DESCRIPTION                                 | TEST CONDITIONS <sup>(1)</sup>        | MIN  | TYP | MAX  | UNIT |
|---------------------|---|---------------------------------------|------|-----|------|------|
| V <sub>OH</sub>     | High-level output voltage                   | VCC = 3.3 V, I <sub>OH</sub> = −20 mA | 2.4  |     |      | V    |
| V <sub>OL</sub>     | Low level output voltage                    | VCC = 3.45 V, I <sub>OL</sub> = 15 mA |      |     | 0.4  | V    |
| I <sub>IH</sub>     | High-level input current <sup>(2) (3)</sup> | VCC = 3.45 V , V <sub>I</sub> = VCC   |      |     | 250  | μA   |
| I <sub>IL</sub>     | Low level input current                     | VCC = 3.45 V, V <sub>I</sub> = 0      | −250 |     |      | μA   |
| I <sub>OZ</sub>     | High-impedance output current               | VCC = 3.45 V                          |      |     | 10   | μA   |
| CURRENT             |   |                                       |      |     |      |      |
| I <sub>CC</sub>     | Supply current <sup>(4)</sup>               | VCC = 3.6 V                           |      |     | 1076 | mA   |
| I <sub>CCI</sub>    |   | VCCI = 3.6 V                          |      |     | 518  |      |
| I <sub>OFFSET</sub> | Supply current <sup>(5)</sup>               | VOFFSET = 8.75 V                      |      |     | 4    | mA   |
| I <sub>BIAS</sub>   |   | VBIAS = 16.5 V                        |      |     | 14   |      |
| I <sub>RESET</sub>  | Supply current                              | VRESET = −10.5 V                      |      |     | 11   | mA   |
| I <sub>TOTAL</sub>  |   | Total Sum                             |      |     | 1623 |      |
| POWER               |   |                                       |      |     |      |      |
| P <sub>CC</sub>     | Supply power dissipation                    | VCC = 3.6 V                           |      |     | 3874 | mW   |
| P <sub>CCI</sub>    |   | VCCI = 3.6 V                          |      |     | 1865 |      |
| P <sub>OFFSET</sub> |   | VOFFSET = 8.75 V                      |      |     | 35   |      |
| P <sub>BIAS</sub>   |   | VBIAS = 16.5 V                        |      |     | 231  |      |
| P <sub>RESET</sub>  |   | VRESET = −10.5 V                      |      |     | 116  |      |
| P <sub>TOTAL</sub>  | Supply power dissipation <sup>(6)</sup>     | Total Sum                             |      |     | 6300 |      |
| CAPACITANCE         |   |                                       |      |     |      |      |
| C <sub>I</sub>      | Input capacitance                           | f = 1 MHz                             |      |     | 10   | pF   |
| C <sub>O</sub>      | Output capacitance                          | f = 1 MHz                             |      |     | 10   | pF   |
| C <sub>M</sub>      | Reset group capacitance<br>MBRST(14:0)      | f = 1 MHz 1920 × 72 micromirrors      | 330  |     | 390  | pF   |

- (1) All voltages are referenced to common ground VSS. Supply voltages VCC, VCCI, VOFFSET, VBIAS, and VRESET are all required for proper DMD operation. VSS must also be connected.
- (2) Applies to LVCMOS input pins only. Does not apply to LVDS pins and MBRST pins.
- (3) LVCMOS input pins utilize an internal 18000 Ω passive resistor for pull-up and pull-down configurations. Refer to [Pin Configuration and Functions](#) to determine pull-up or pull-down configuration used.
- (4) To prevent excess current, the supply voltage delta |VCCI – VCC| must be less than specified limit.
- (5) To prevent excess current, the supply voltage delta |VBIAS – VOFFSET| must be less than specified limit.
- (6) Total power on the active micromirror array is the sum of the electrical power dissipation and the absorbed power from the illumination source. See the [Micromirror Array Temperature Calculation](#).

## 6.6 Timing Requirements

Over [Recommended Operating Conditions](#) unless otherwise noted.

| DESCRIPTION <sup>(1)</sup>    |                |   | MIN   | TYP  | MAX   | UNIT |    |
|-------------------------------|----------------|---|---|------|-------|------|----|
| SCP INTERFACE <sup>(2)</sup>  |                |   |   |      |       |      |    |
| t <sub>r</sub>                | Rise time      | 20% to 80%  |   |      | 200   | ns   |    |
| t <sub>f</sub>                | Fall time      | 80% to 20%  |   |      | 200   | ns   |    |
| LVDS INTERFACE <sup>(2)</sup> |                |   |   |      |       |      |    |
| t <sub>r</sub>                | Rise time      | 20% to 80%  | 100   |      | 400   | ps   |    |
| t <sub>f</sub>                | Fall time      | 80% to 20%  | 100   |      | 400   | ps   |    |
| LVDS CLOCKS <sup>(3)</sup>    |                |   |   |      |       |      |    |
| t <sub>c</sub>                | Cycle time     | DCLK_A, 50% to 50%                                | 2.5   |      |       | ns   |    |
|                               |                | DCLK_B, 50% to 50%                                | 2.5   |      |       |      |    |
| t <sub>w</sub>                | Pulse duration | DCLK_A, 50% to 50%                                | 1.19  | 1.25 |       | ns   |    |
|                               |                | DCLK_B, 50% to 50%                                | 1.19  | 1.25 |       |      |    |
| LVDS INTERFACE <sup>(3)</sup> |                |   |   |      |       |      |    |
| t <sub>su</sub>               | Setup time     | D_A(15:0) before rising or falling edge of DCLK_A | 0.1   |      |       | ns   |    |
|                               |                | D_B(15:0) before rising or falling edge of DCLK_B | 0.1   |      |       |      |    |
| t <sub>su</sub>               | Setup time     | SCTRL_A before rising or falling edge of DCLK_A   | 0.1   |      |       | ns   |    |
|                               |                | SCTRL_B before rising or falling edge of DCLK_B   | 0.1   |      |       |      |    |
| t <sub>h</sub>                | Hold time      | D_A(15:0) after rising or falling edge of DCLK_A  | 0.4   |      |       | ns   |    |
|                               |                | D_B(15:0) after rising or falling edge of DCLK_B  | 0.4   |      |       |      |    |
| t <sub>h</sub>                | Hold time      | SCTRL_A after rising or falling edge of DCLK_A    | 0.3   |      |       | ns   |    |
|                               |                | SCTRL_B after rising or falling edge of DCLK_B    | 0.3   |      |       |      |    |
| LVDS INTERFACE <sup>(4)</sup> |                |   |   |      |       |      |    |
| t <sub>skew</sub>             | Skew time      | Channel B relative to Channel A <sup>(4)</sup>    | Channel A includes the following LVDS pairs:<br>DCLK_AP and DCLK_AN<br>SCTRL_AP and SCTRL_AN<br>D_AP(15:0) and D_AN(15:0) |      | -1.25 | 1.25 | ns |
|                               |                |   | Channel B includes the following LVDS pairs:<br>DCLK_BP and DCLK_BN<br>SCTRL_BP and SCTRL_BN<br>D_BP(15:0) and D_BN(15:0) |      |       |      |    |

(1) Refer to [Pin Configuration and Functions](#) for pin details.

(2) Refer to [Figure 7](#)

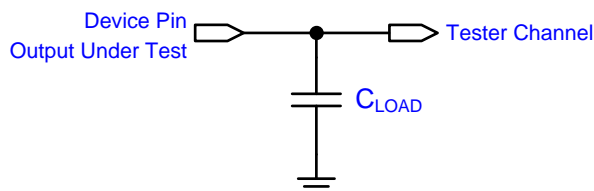
(3) Refer to [Figure 8](#)

(4) Refer to [Figure 9](#)

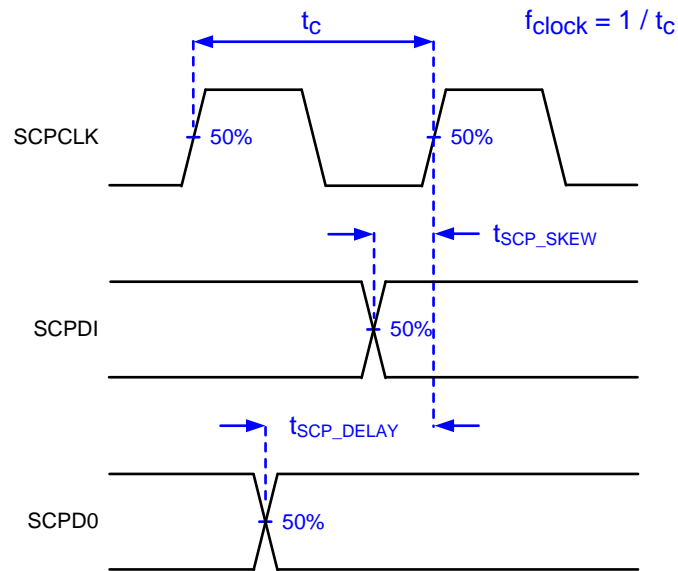
### Timing Requirements

The data sheet provides timing at the device pin. For output timing analysis, the tester pin electronics and its transmission line effects must be taken into account. [Figure 2](#) shows an equivalent test load circuit for the output under test. The load capacitance value stated is only for characterization and measurement of AC timing signals. This load capacitance value does not indicate the maximum load the device is capable of driving.

Timing reference loads are not intended as a precise representation of any particular system environment or depiction of the actual load presented by a production test. System designers should use IBIS or other simulation tools to correlate the timing reference load to a system environment. Refer to the [Application and Implementation](#) section.



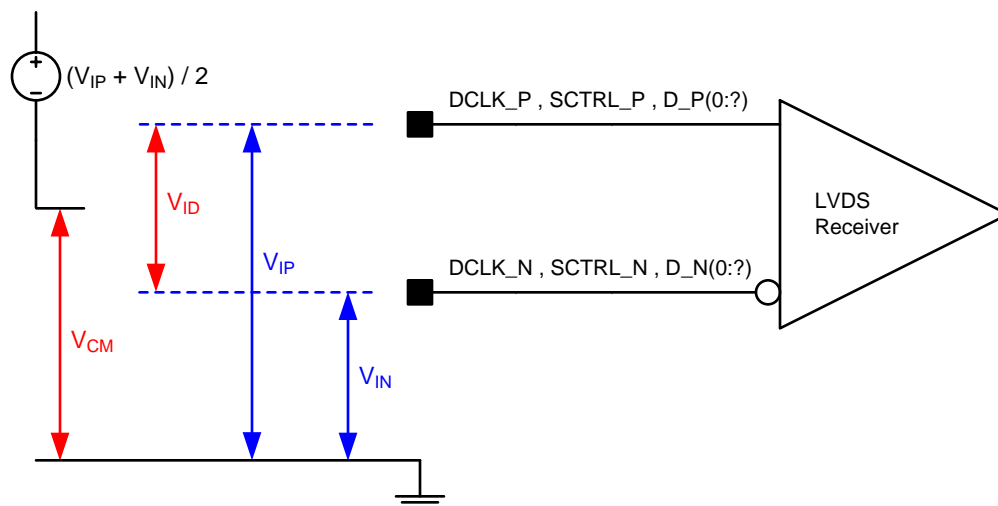
**Figure 2. Test Load Circuit**



Not to scale.

Refer to SCP Interface section of the Recommended Operating Conditions table.

**Figure 3. SCP Timing Parameters**

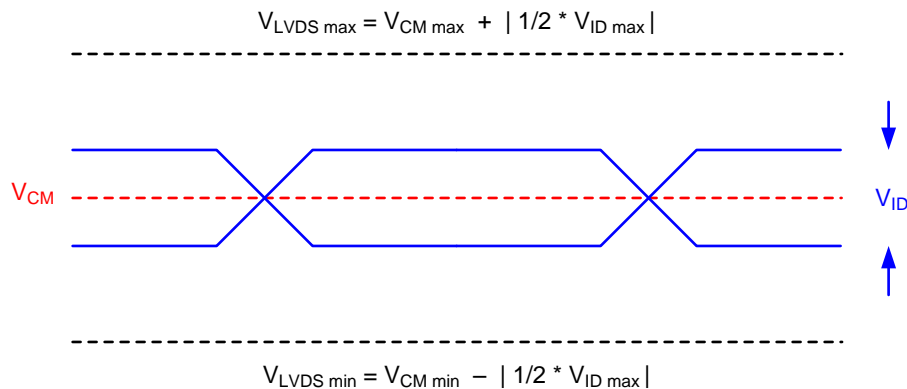


Refer to LVDS Interface section of the Recommended Operating Conditions table.

Refer to Pin Configuration and Functions for list of LVDS pins.

**Figure 4. LVDS Voltage Definitions (References)**

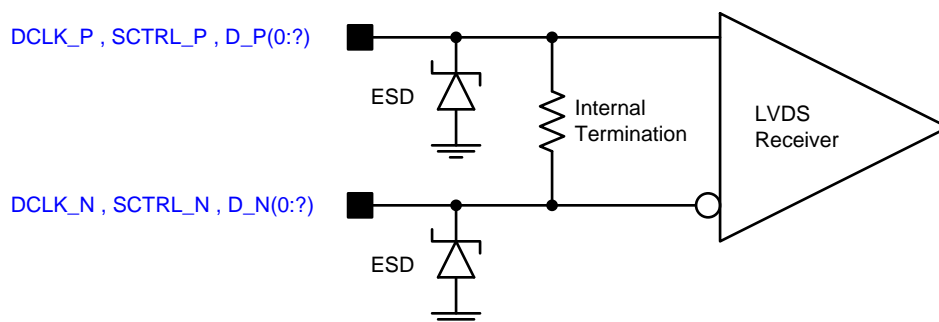




Not to scale.

Refer to LVDS Interface section of the Recommended Operating Conditions table.

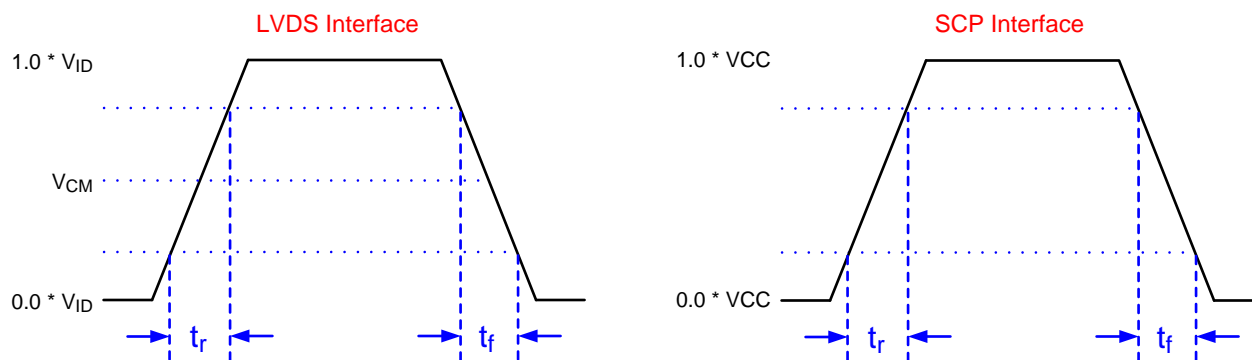
**Figure 5. LVDS Voltage Parameters**



Refer to LVDS Interface section of the Recommended Operating Conditions table.

Refer to Pin Configuration and Functions for list of LVDS pins.

**Figure 6. LVDS Equivalent Input Circuit**

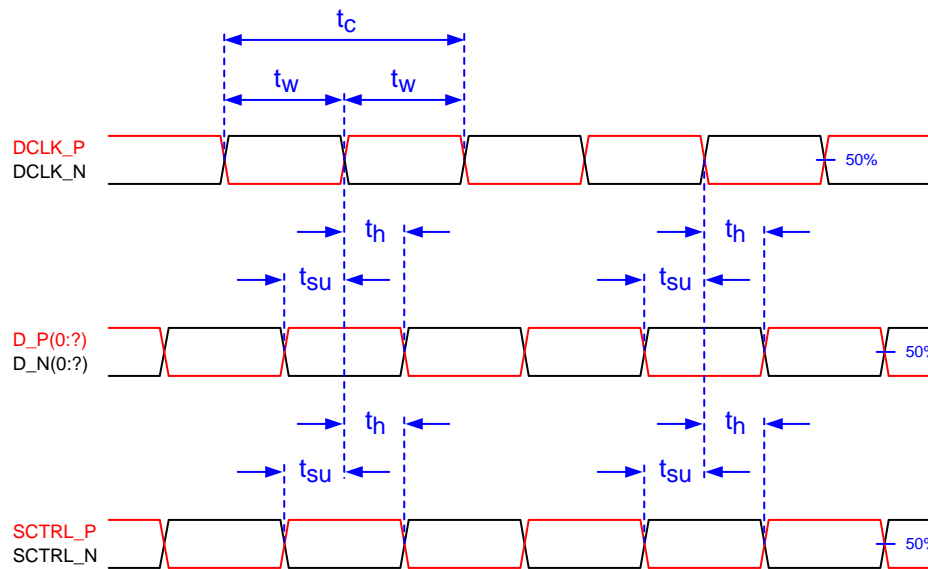


Not to scale.

Refer to the [Timing Requirements](#)

Refer to Pin Configuration and Functions for list of LVDS pins and SCP pins..

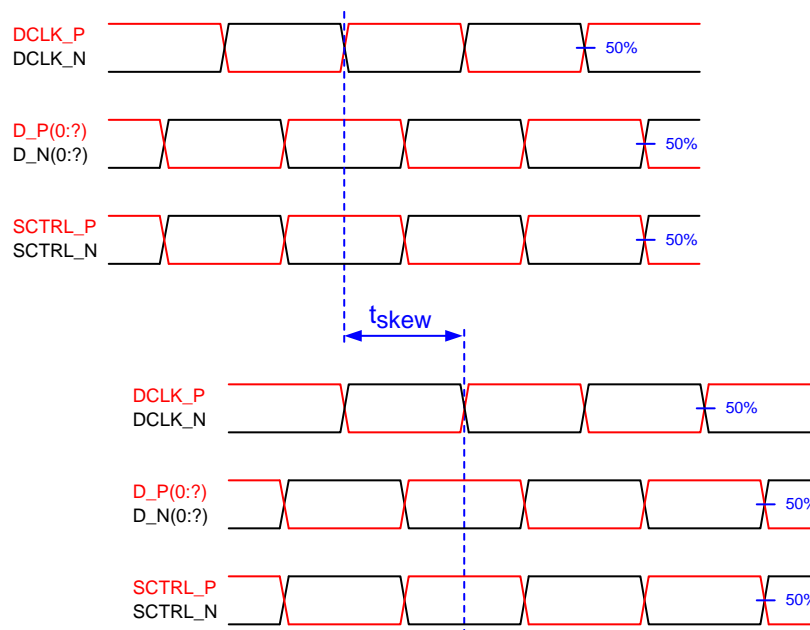
**Figure 7. Rise Time and Fall Time**



Not to scale.

Refer to LVDS INTERFACE section in the [Timing Requirements](#) table.

**Figure 8. Timing Requirement Parameter Definitions**



Not to scale.

Refer to LVDS INTERFACE section in the [Timing Requirements](#) table.

**Figure 9. LVDS Interface Channel Skew Definition**

## 6.7 Typical Characteristics

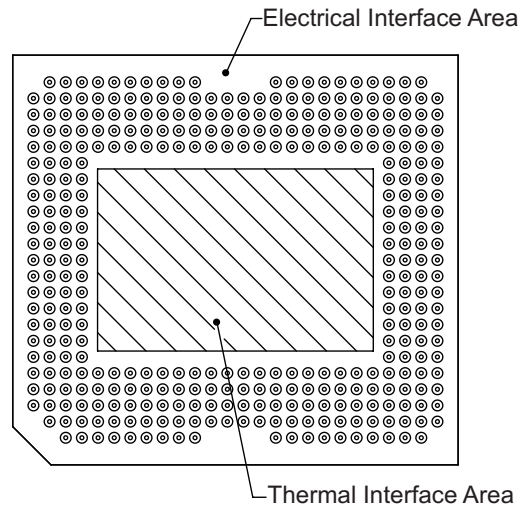
The DLP6500 DMD is controlled by the DLPC900 controller. The controller has two modes of operation. The first is Video mode where the video source is displayed on the DMD. The second is Pattern mode, where the patterns are pre-stored in flash memory and then streamed to the DMD. The allowed DMD pattern rate depends on which mode and bit-depth is selected.

**Table 2. Bit Depth versus Pattern Rate**

| BIT DEPTH | VIDEO MODE RATE (Hz) | PATTERN MODE RATE (Hz) |
|-----------|----------------------|------------------------|
| 1         | 2880                 | 9523                   |
| 2         | 1440                 | 3289                   |
| 3         | 960                  | 2638                   |
| 4         | 720                  | 1364                   |
| 5         | 480                  | 823                    |
| 6         | 480                  | 672                    |
| 7         | 360                  | 500                    |
| 8         | 247                  | 247                    |

## 6.8 System Mounting Interface Loads

| PARAMETER  |                 | MIN | NOM | MAX   | UNIT |
|--|-----------------|-----|-----|-------|------|
| Maximum system mounting interface load to be applied to the: | (See Figure 10) |     |     | 11.30 | Kg   |
| • Thermal Interface area                                     |                 |     |     |       |      |
| • Electrical Interface areas                                 |                 |     |     |       |      |
| Maximum Load 22.64 Applied per condition 2                   |                 |     |     |       | Kg   |
| • Thermal Interface area                                     | (See Figure 10) |     |     | 0     | Kg   |
| • Electrical Interface areas                                 |                 |     |     | 22.60 | Kg   |

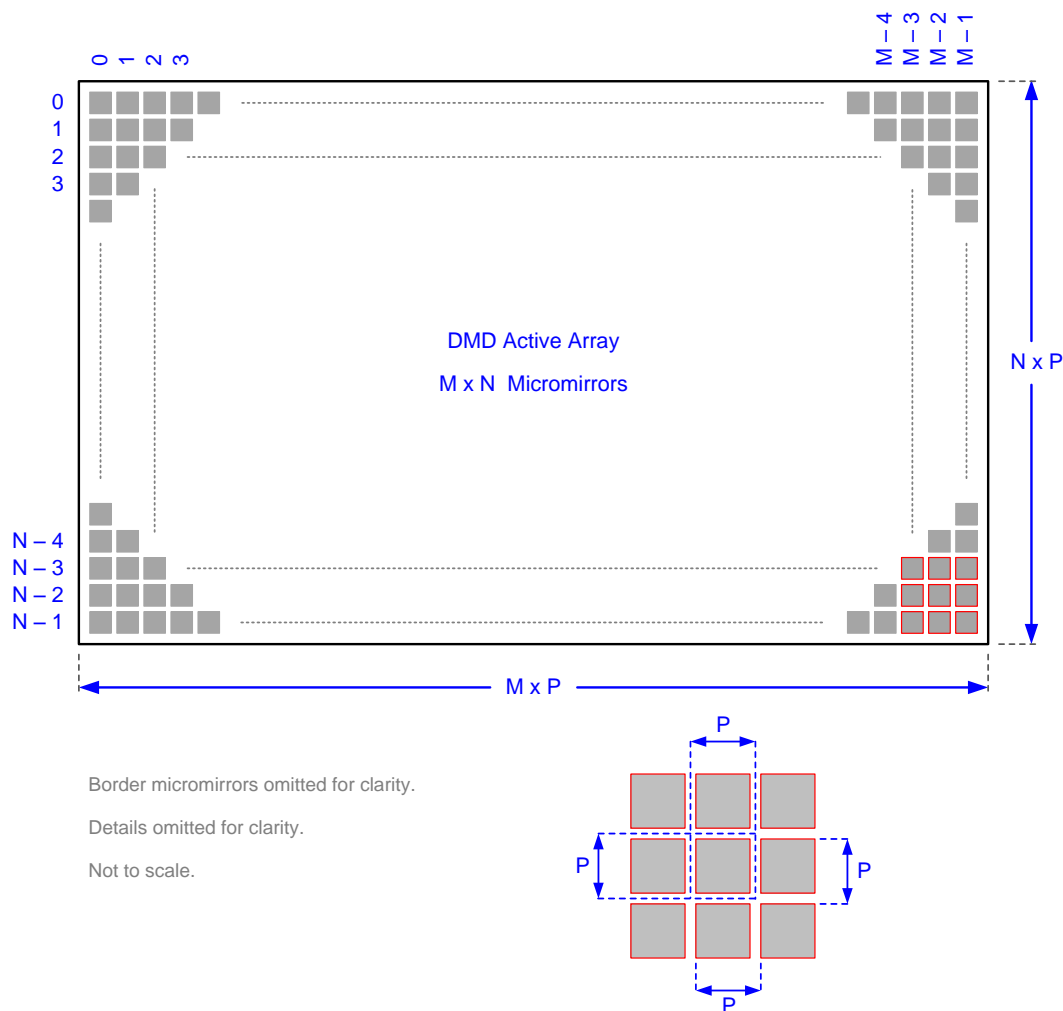


**Figure 10. System Mounting Interface Loads**

## 6.9 Micromirror Array Physical Characteristics

|   |                                 |  | VALUE   | UNIT               |
|---|---------------------------------|--|---------|--------------------|
| M | Number of active columns        | See Figure 11                            | 1920    | micromirrors       |
| N | Number of active rows           |  | 1080    | micromirrors       |
| P | Micromirror (pixel) pitch       |  | 7.56    | μm                 |
|   | Micromirror active array width  |  | 14.5152 | mm                 |
|   | Micromirror active array height |  | 8.1648  | mm                 |
|   | Micromirror active border       | Pond of micromirror (POM) <sup>(1)</sup> | 14      | micromirrors /side |

- (1) The structure and qualities of the border around the active array includes a band of partially functional micromirrors called the POM. These micromirrors are structurally and/or electrically prevented from tilting toward the bright or ON state, but still require an electrical bias to tilt toward OFF.



Refer to section [Micromirror Array Physical Characteristics](#) table for M, N, and P specifications.

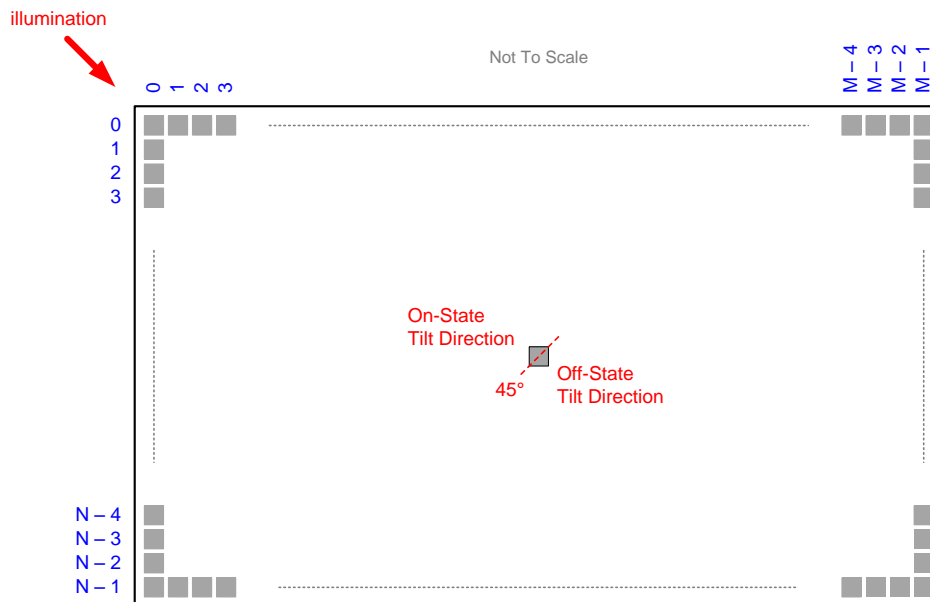
**Figure 11. Micromirror Array Physical Characteristics**

## 6.10 Micromirror Array Optical Characteristics

See [Optical Interface and System Image Quality](#) for important information

| PARAMETER  | CONDITIONS                      | MIN | NOM | MAX | UNIT         |
|--|---------------------------------|-----|-----|-----|--------------|
| $\alpha$ Micromirror tilt angle  | DMD landed state <sup>(1)</sup> |     | 12  |     | °            |
| $\beta$ Micromirror tilt angle tolerance <sup>(1) (2) (3) (4) (5)</sup>              |                                 | –1  |     | 1   | °            |
| Micromirror tilt direction <sup>(5) (6) (7)</sup>                                    |                                 | 44  | 45  | 46  | °            |
| Number of out-of-specification micromirrors <sup>(8)</sup>                           | Adjacent micromirrors           |     |     | 0   | micromirrors |
|  | Non-adjacent micromirrors       |     |     | 10  |              |
| Micromirror crossover time <sup>(9) (10)</sup>                                       | Typical performance             |     | 2.5 |     | μs           |
| Micromirror switching time <sup>(10)</sup>   | Typical performance             |     | 5   |     | μs           |
| DMD photopic efficiency within the wavelength range 420 nm to 700 nm <sup>(11)</sup> |                                 |     | 66% |     |              |

- (1) Measured relative to the plane formed by the overall micromirror array.
- (2) Additional variation exists between the micromirror array and the package datums.
- (3) Represents the landed tilt angle variation relative to the nominal landed tilt angle.
- (4) Represents the variation that can occur between any two individual micromirrors, located on the same device or located on different devices.
- (5) For some applications, it is critical to account for the micromirror tilt angle variation in the overall system optical design. With some system optical designs, the micromirror tilt angle variation within a device may result in perceivable non-uniformities in the light field reflected from the micromirror array. With some system optical designs, the micromirror tilt angle variation between devices may result in colorimetry variations, system efficiency variations or system contrast variations.
- (6) When the micromirror array is landed (not parked), the tilt direction of each individual micromirror is dictated by the binary contents of the CMOS memory cell associated with each individual micromirror. A binary value of 1 results in a micromirror landing in the ON State direction. A binary value of 0 results in a micromirror landing in the OFF State direction.
- (7) Refer to [Figure 12](#)
- (8) An out-of-specification micromirror is defined as a micromirror that is unable to transition between the two landed states within the specified Micromirror Switching Time.
- (9) Micromirror crossover time is primarily a function of the natural response time of the micromirrors.
- (10) Performance as measured at the start of life.
- (11) Efficiency numbers assume 24-degree illumination angle, F/2.4 illumination and collection cones, uniform source spectrum, and uniform pupil illumination. Efficiency numbers assume 100% electronic mirror duty cycle and do not include optical overfill loss. Note that this number is specified under conditions described above and deviations from the specified conditions could result in decreased efficiency.



Refer to section [Micromirror Array Physical Characteristics](#) table for M, N, and P specifications.

**Figure 12. Micromirror Landed Orientation and Tilt**

## 6.11 Window Characteristics

| PARAMETER <sup>(1)</sup>   | CONDITIONS   | MIN | TYP   | MAX | UNIT |
|--|--|-----|-------|-----|------|
| Window material designation S600   | Corning 7056   |     |       |     |      |
| Window refractive index  | at wavelength 589 nm   |     | 1.487 |     |      |
| Window aperture  | See <sup>(2)</sup>   |     |       |     |      |
| Illumination overfill  | Refer to <a href="#">Illumination Overfill</a>   |     |       |     |      |
| Window transmittance, single-pass through both surfaces and glass <sup>(3)</sup> | Minimum within the wavelength range 420 nm to 680 nm. Applies to all angles 0° to 30° AOI. | 97% |       |     |      |
|  | Average over the wavelength range 420 nm to 680 nm. Applies to all angles 30° to 45° AOI.  | 97% |       |     |      |

(1) See [Window Characteristics and Optics](#) for more information.

(2) For details regarding the size and location of the window aperture, see the package mechanical characteristics listed in the Mechanical ICD in the Mechanical, Packaging, and Orderable Information section.

(3) See the TI application report [DLPA031](#), *Wavelength Transmittance Considerations for DLP™ DMD Window*.

## 6.12 Chipset Component Usage Specification

The DLP6500FYE is a component of one or more DLP® chipsets. Reliable function and operation of the DLP6500FYE requires that it be used in conjunction with the other components of the applicable DLP chipset, including those components that contain or implement TI DMD control technology. TI DMD control technology is the TI technology and devices for operating or controlling a DLP DMD.

## 7 Detailed Description

### 7.1 Overview

DLP6500FYE is a 0.65 inch diagonal spatial light modulator which consists of an array of highly reflective aluminum micromirrors. Pixel array size and square grid pixel arrangement are shown in [Figure 11](#).

The DMD is an electrical input, optical output micro-electrical-mechanical system (MEMS). The electrical interface is Low Voltage Differential Signaling (LVDS), Double Data Rate (DDR).

DLP6500FYE DMD consists of a two-dimensional array of 1-bit CMOS memory cells. The array is organized in a grid of  $M$  memory cell columns by  $N$  memory cell rows. Refer to the [Functional Block Diagram](#).

The positive or negative deflection angle of the micromirrors can be individually controlled by changing the address voltage of underlying CMOS addressing circuitry and micromirror reset signals (MBRST).

Each cell of the  $M \times N$  memory array drives its true and complement ('Q' and 'QB') data to two electrodes underlying one micromirror, one electrode on each side of the diagonal axis of rotation. Refer to [Micromirror Array Optical Characteristics](#). The micromirrors are electrically tied to the micromirror reset signals (MBRST) and the micromirror array is divided into reset groups.

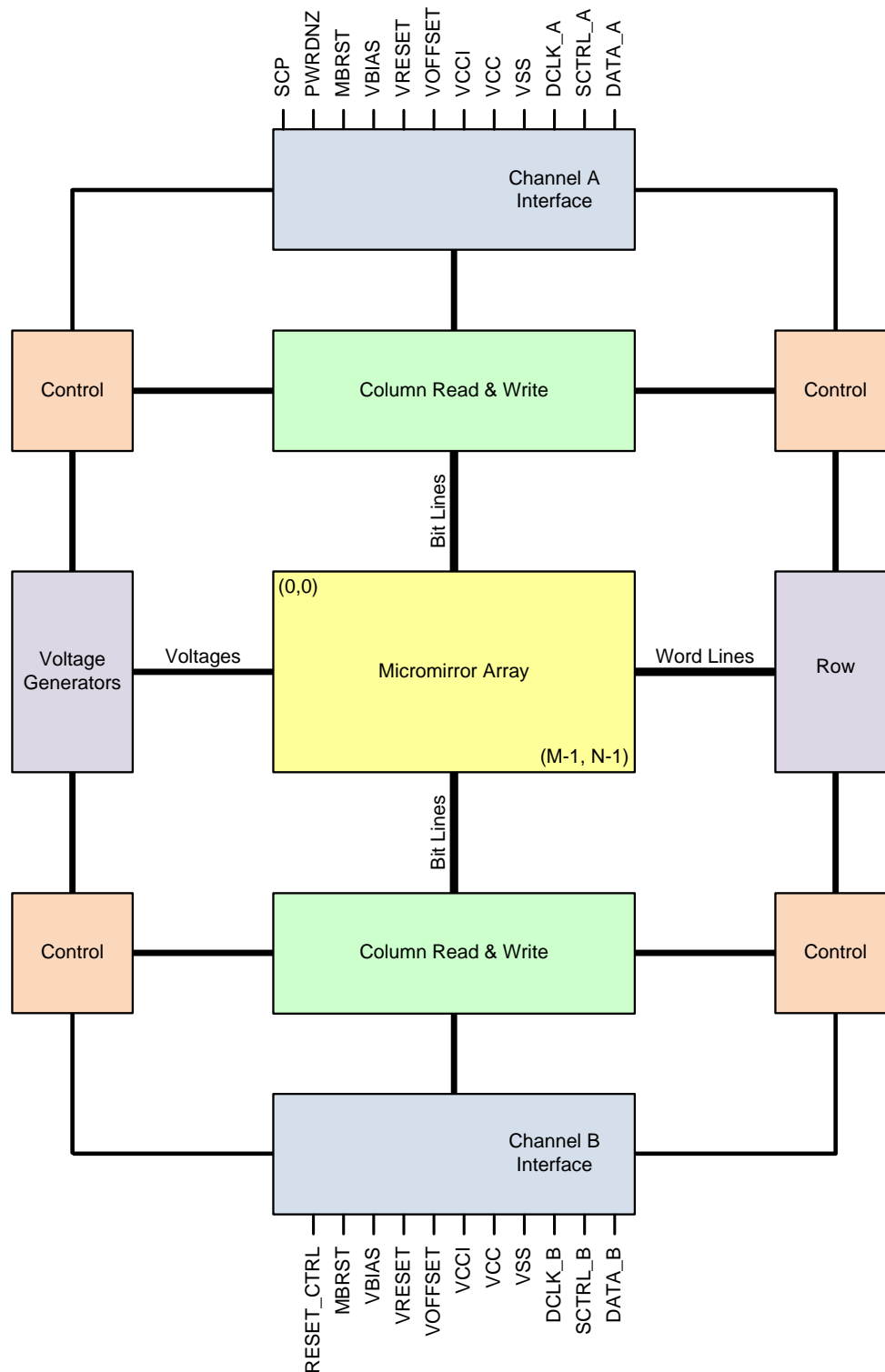
Electrostatic potentials between a micromirror and its memory data electrodes cause the micromirror to tilt toward the illumination source in a DLP projection system or away from it, thus reflecting its incident light into or out of an optical collection aperture. The positive (+) tilt angle state corresponds to an 'on' pixel, and the negative (–) tilt angle state corresponds to an 'off' pixel.

Refer to [Micromirror Array Optical Characteristics](#) for the  $\pm$  tilt angle specifications. Refer to [Pin Configuration and Functions](#) for more information on micromirror reset control.



## 7.2 Functional Block Diagram

Not to Scale. Details Omitted for Clarity. See Accompanying Notes in this Section.



For pin details on Channels A, B, C, and D, refer to [Pin Configuration and Functions](#) and LVDS Interface section of [Timing Requirements](#).

### 7.3 Feature Description

DLP6500FYE device consists of highly reflective, digitally switchable, micrometer-sized mirrors (micromirrors) organized in a two-dimensional orthogonal pixel array. Refer to [Figure 11](#) and [Figure 13](#).

Each aluminum micromirror is switchable between two discrete angular positions,  $-\alpha$  and  $+\alpha$ . The angular positions are measured relative to the micromirror array plane, which is parallel to the silicon substrate. Refer to [Micromirror Array Optical Characteristics](#) and [Figure 14](#).

The parked position of the micromirror is not a latched position and is therefore not necessarily perfectly parallel to the array plane. Individual micromirror flat state angular positions may vary. Tilt direction of the micromirror is perpendicular to the hinge-axis. The on-state landed position is directed toward the left-top edge of the package, as shown in [Figure 13](#).

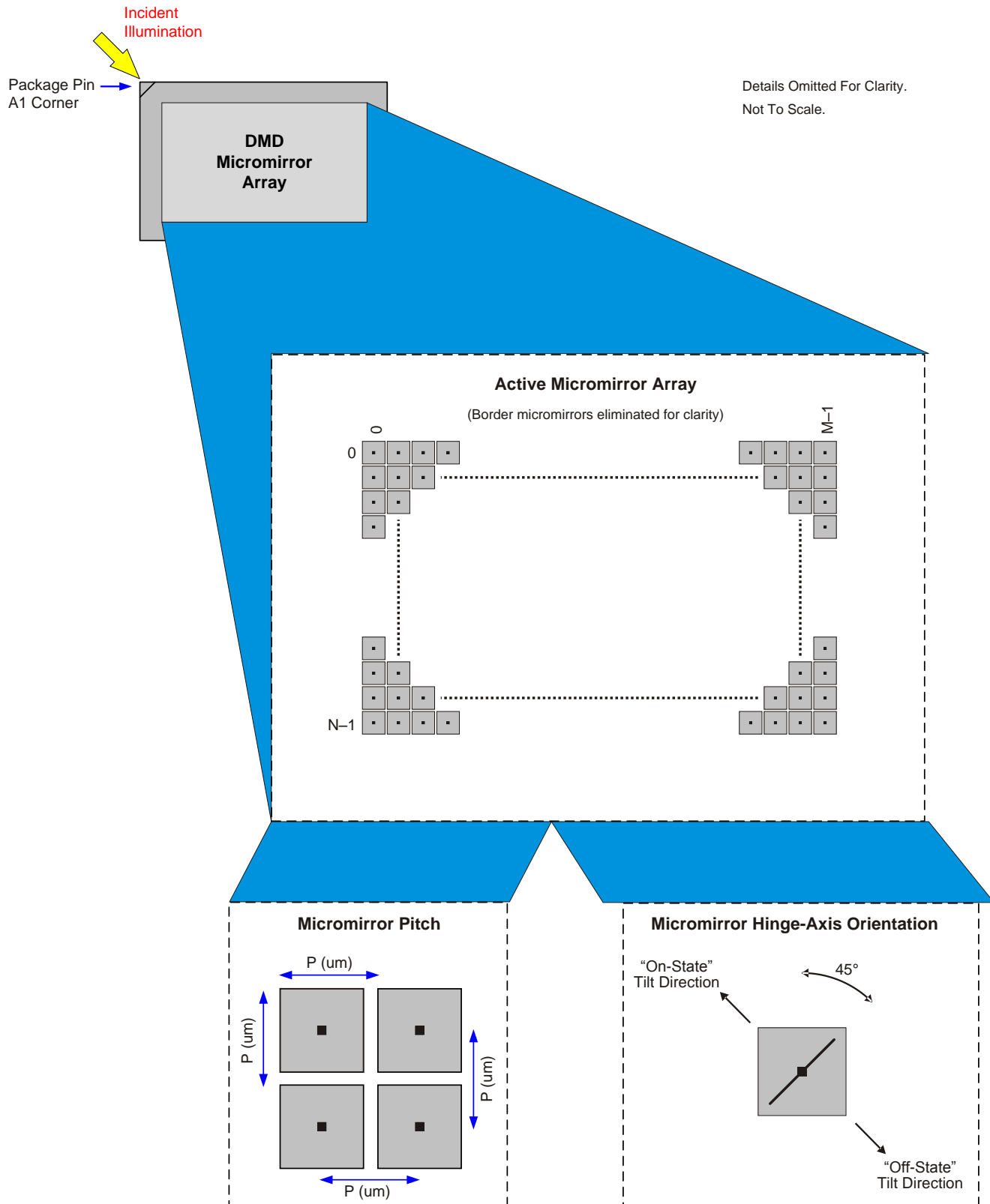
Each individual micromirror is positioned over a corresponding CMOS memory cell. The angular position of a specific micromirror is determined by the binary state (logic 0 or 1) of the corresponding CMOS memory cell contents, after the mirror *clocking pulse* is applied. The angular position ( $-\alpha$  and  $+\alpha$ ) of the individual micromirrors changes synchronously with a micromirror clocking pulse, rather than being coincident with the CMOS memory cell data update.

Writing logic 1 into a memory cell followed by a mirror clocking pulse results in the corresponding micromirror switching to a  $+\alpha$  position. Writing logic 0 into a memory cell followed by a mirror clocking pulse results in the corresponding micromirror switching to a  $-\alpha$  position.

Updating the angular position of the micromirror array consists of two steps. First, update the contents of the CMOS memory. Second, apply a micromirror reset to all or a portion of the micromirror array (depending upon the configuration of the system). Micromirror reset pulses are generated internally by the DLP6500FYE DMD, with application of the pulses being coordinated by the DLPC900 display controller.

For more information, see the TI application report [DLPA008A](#), *DMD101: Introduction to Digital Micromirror Device (DMD) Technology*.

## Feature Description (continued)

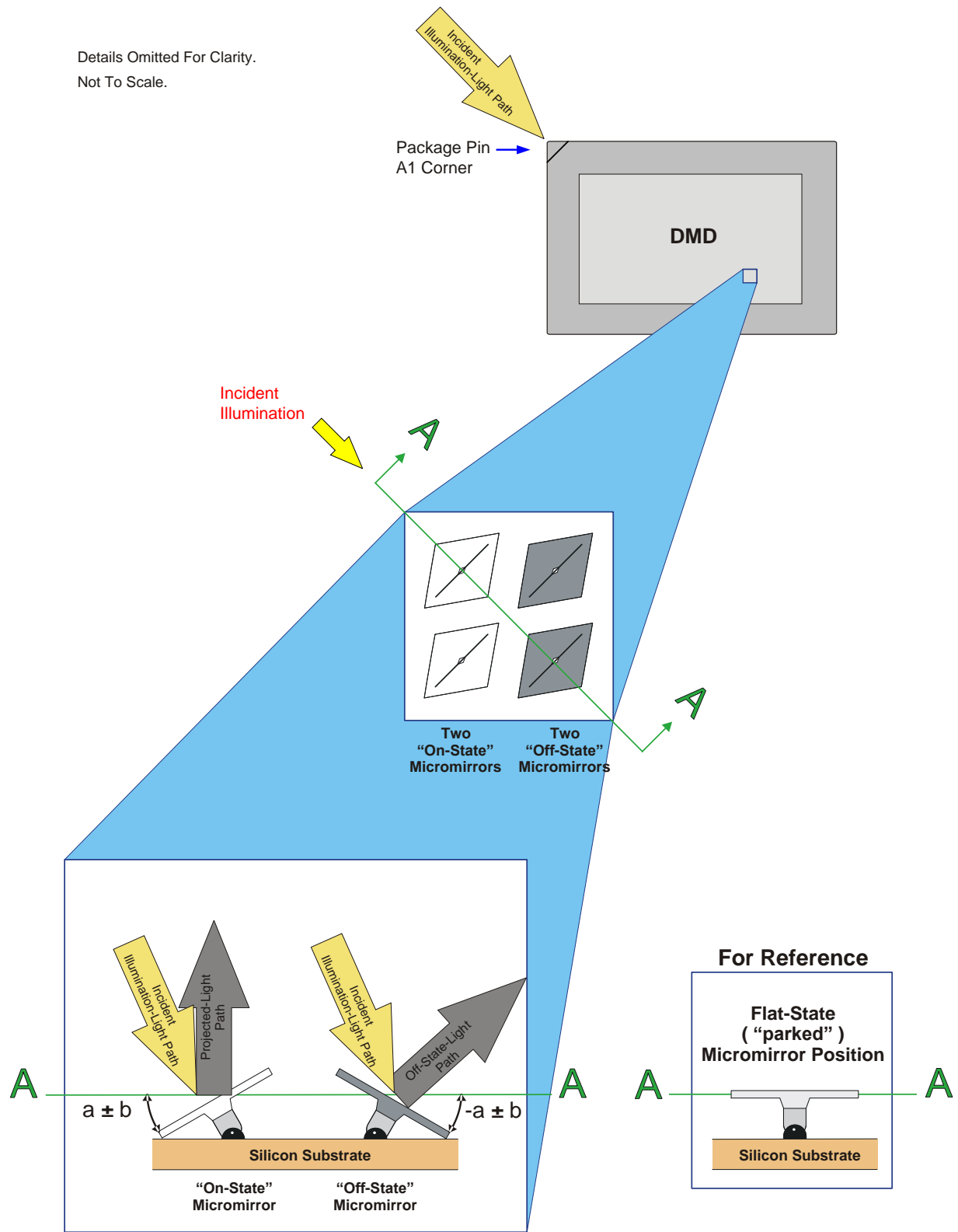


Refer to Micromirror Array Physical Characteristics, [Figure 11](#), and Micromirror Landed Orientation and Tilt

**Figure 13. Micromirror Array, Pitch, Hinge Axis Orientation**

## Feature Description (continued)

Details Omitted For Clarity.  
Not To Scale.



Micromirror States: On, Off, Flat

**Figure 14. Micromirror States: On, Off, Flat**

## 7.4 Device Functional Modes

DLP6500FYE is part of the chipset comprising of the DLP6500FYE DMD and DLPC900 display controller. To ensure reliable operation, DLP6500FYE DMD must always be used with a DLPC900 display controller.

DMD functional modes are controlled by the DLPC900 digital display controller. See the DLPC900 data sheet listed in Related Documents. Contact a TI applications engineer for more information.

## 7.5 Window Characteristics and Optics

---

### NOTE

TI assumes no responsibility for image quality artifacts or DMD failures caused by optical system operating conditions exceeding limits described previously.

---

### 7.5.1 Optical Interface and System Image Quality

TI assumes no responsibility for end-equipment optical performance. Achieving the desired end-equipment optical performance involves making trade-offs between numerous component and system design parameters. Optimizing system optical performance and image quality strongly relate to optical system design parameter trades. Although it is not possible to anticipate every conceivable application, projector image quality and optical performance is contingent on compliance to the optical system operating conditions described in the following sections.

### 7.5.2 Numerical Aperture and Stray Light Control

The angle defined by the numerical aperture of the illumination and projection optics at the DMD optical area should be the same. This angle should not exceed the nominal device mirror tilt angle unless appropriate apertures are added in the illumination and/or projection pupils to block out flat-state and stray light from the projection lens. The mirror tilt angle defines DMD capability to separate the "ON" optical path from any other light path, including undesirable flat-state specular reflections from the DMD window, DMD border structures, or other system surfaces near the DMD such as prism or lens surfaces. If the numerical aperture exceeds the mirror tilt angle, or if the projection numerical aperture angle is more than two degrees larger than the illumination numerical aperture angle, objectionable artifacts in the display's border and/or active area could occur.

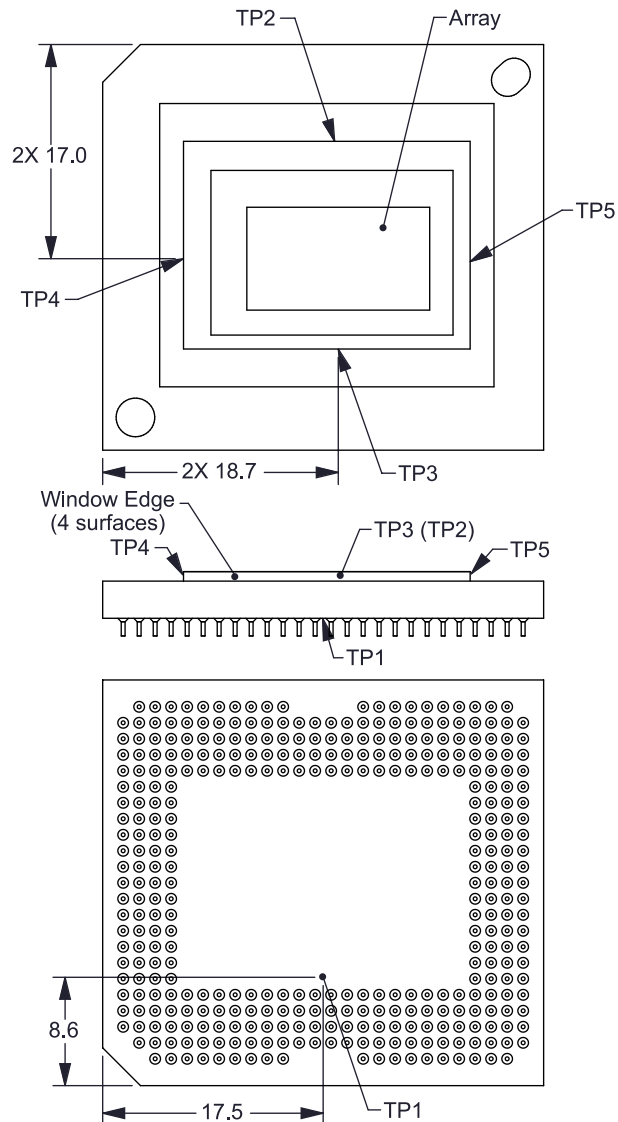
### 7.5.3 Pupil Match

TI's optical and image quality specifications assume that the exit pupil of the illumination optics is nominally centered within 2° (two degrees) of the entrance pupil of the projection optics. Misalignment of pupils can create objectionable artifacts in the display's border and/or active area, which may require additional system apertures to control, especially if the numerical aperture of the system exceeds the pixel tilt angle.

### 7.5.4 Illumination Overfill

The active area of the device is surrounded by an aperture on the inside DMD window surface that masks structures of the DMD device assembly from normal view. The aperture is sized to anticipate several optical operating conditions. Overfill light illuminating the window aperture can create artifacts from the edge of the window aperture opening and other surface anomalies that may be visible on the screen. The illumination optical system should be designed to limit light flux incident anywhere on the window aperture from exceeding approximately 10% of the average flux level in the active area. Depending on the particular system's optical architecture, overfill light may have to be further reduced below the suggested 10% level in order to be acceptable.

## 7.6 Micromirror Array Temperature Calculation



**Figure 15. DMD Thermal Test Points**

Micromirror array temperature can be computed analytically from measurement points on the outside of the package, the ceramic package thermal resistance, the electrical power dissipation, and the illumination heat load. The relationship between micromirror array temperature and the reference ceramic temperature is provided by the following equations:

$$T_{\text{ARRAY}} = T_{\text{CERAMIC}} + (Q_{\text{ARRAY}} \times R_{\text{ARRAY-TO-CERAMIC}}) \quad (1)$$

$$Q_{\text{ARRAY}} = Q_{\text{ELECTRICAL}} + Q_{\text{ILLUMINATION}} \quad (2)$$

$$Q_{\text{ILLUMINATION}} = (C_{\text{L2W}} \times \text{SL})$$

where

- $T_{\text{ARRAY}}$  = Computed micromirror array temperature (°C)
- $T_{\text{CERAMIC}}$  = Measured ceramic temperature (°C), TP1 location in [Figure 15](#)
- $R_{\text{ARRAY-TO-CERAMIC}}$  = DMD package thermal resistance from micromirror array to outside ceramic (°C/W) specified in [Thermal Information](#)
- $Q_{\text{ARRAY}}$  = Total DMD power; electrical, specified in [Electrical Characteristics](#), plus absorbed (calculated) (W)
- $Q_{\text{ELECTRICAL}}$  = Nominal DMD electrical power dissipation (W), specified in [Electrical Characteristics](#)

## Micromirror Array Temperature Calculation (continued)

- $C_{L2W}$  = Conversion constant for screen lumens to absorbed optical power on the DMD (W/lm) specified below
- SL = Measured ANSI screen lumens (lm) (3)

Electrical power dissipation of the DMD is variable and depends on the voltages, data rates and operating frequencies. The nominal electrical power dissipation to use when calculating array temperature is 2.9 Watts . Absorbed optical power from the illumination source is variable and depends on the operating state of the micromirrors and the intensity of the light source. Equations shown above are valid for a 1-chip DMD system with total projection efficiency through the projection lens from DMD to the screen of 87%.

The conversion constant  $C_{L2W}$  is based on the DMD micromirror array characteristics. It assumes a spectral efficiency of 300 lm/W for the projected light and illumination distribution of 83.7% on the DMD active array, and 16.3% on the DMD array border and window aperture. The conversion constant is calculated to be 0.00293 W/lm.

Sample Calculation for typical projection application:

$T_{CERAMIC} = 55^{\circ}\text{C}$ , assumed system measurement; see [Recommended Operating Conditions](#) for specific limits  
SL = 2000 lm

$Q_{ELECTRICAL} = 2.9 \text{ W}$  (see the maximum power specifications in [Electrical Characteristics](#) )

$C_{L2W} = 0.00293 \text{ W/lm}$

$Q_{ARRAY} = 2.9 \text{ W} + (0.00293 \text{ W/lm} \times 2000 \text{ lm}) = 8.76 \text{ W}$

$T_{ARRAY} = 55^{\circ}\text{C} + (8.76 \text{ W} \times 0.6 \times \text{C/W}) = 60.26^{\circ}\text{C}$

## 7.7 Micromirror Landed-on/Landed-Off Duty Cycle

### 7.7.1 Definition of Micromirror Landed-On/Landed-Off Duty Cycle

The micromirror landed-on/landed-off duty cycle (landed duty cycle) denotes the amount of time (as a percentage) that an individual micromirror is landed in the On-state versus the amount of time the same micromirror is landed in the Off-state.

As an example, a landed duty cycle of 100/0 indicates that the referenced pixel is in the On-state 100% of the time (and in the Off-state 0% of the time); whereas 0/100 would indicate that the pixel is in the Off-state 100% of the time. Likewise, 50/50 indicates that the pixel is On 50% of the time and Off 50% of the time.

Note that when assessing landed duty cycle, the time spent switching from one state (ON or OFF) to the other state (OFF or ON) is considered negligible and is thus ignored.

Since a micromirror can only be landed in one state or the other (On or Off), the two numbers (percentages) always add to 100.

### 7.7.2 Landed Duty Cycle and Useful Life of the DMD

Knowing the long-term average landed duty cycle (of the end product or application) is important because subjecting all (or a portion) of the DMD's micromirror array (also called the active array) to an asymmetric landed duty cycle for a prolonged period of time can reduce the DMD's usable life.

Note that it is the symmetry/asymmetry of the landed duty cycle that is of relevance. The symmetry of the landed duty cycle is determined by how close the two numbers (percentages) are to being equal. For example, a landed duty cycle of 50/50 is perfectly symmetrical whereas a landed duty cycle of 100/0 or 0/100 is perfectly asymmetrical.

### 7.7.3 Landed Duty Cycle and Operational DMD Temperature

Operational DMD Temperature and Landed Duty Cycle interact to affect the DMD's usable life, and this interaction can be exploited to reduce the impact that an asymmetrical Landed Duty Cycle has on the DMD's usable life. This is quantified in the de-rating curve shown in [Figure 1](#). The importance of this curve is that:

- All points along this curve represent the same usable life.
- All points above this curve represent lower usable life (and the further away from the curve, the lower the usable life).
- All points below this curve represent higher usable life (and the further away from the curve, the higher the usable life).

## Micromirror Landed-on/Landed-Off Duty Cycle (continued)

In practice, this curve specifies the Maximum Operating DMD Temperature that the DMD should be operated at for a give long-term average Landed Duty Cycle.

### 7.7.4 Estimating the Long-Term Average Landed Duty Cycle of a Product or Application

During a given period of time, the Landed Duty Cycle of a given pixel follows from the image content being displayed by that pixel.

For example, in the simplest case, when displaying pure-white on a given pixel for a given time period, that pixel will experience a 100/0 Landed Duty Cycle during that time period. Likewise, when displaying pure-black, the pixel will experience a 0/100 Landed Duty Cycle.

Between the two extremes (ignoring for the moment color and any image processing that may be applied to an incoming image), the Landed Duty Cycle tracks one-to-one with the gray scale value, as shown in [Table 3](#).

**Table 3. Grayscale Value and Landed Duty Cycle**

| GRAYSCALE VALUE | LANDED DUTY CYCLE |
|-----------------|-------------------|
| 0%              | 0/100             |
| 10%             | 10/90             |
| 20%             | 20/80             |
| 30%             | 30/70             |
| 40%             | 40/60             |
| 50%             | 50/50             |
| 60%             | 60/40             |
| 70%             | 70/30             |
| 80%             | 80/20             |
| 90%             | 90/10             |
| 100%            | 100/0             |

Accounting for color rendition (but still ignoring image processing) requires knowing both the color intensity (from 0% to 100%) for each constituent primary color (red, green, and/or blue) for the given pixel as well as the color cycle time for each primary color, where “color cycle time” is the total percentage of the frame time that a given primary must be displayed in order to achieve the desired white point.

During a given period of time, the landed duty cycle of a given pixel can be calculated as follows:

$$\text{Landed Duty Cycle} = (\text{Red\_Cycle\_}\% \times \text{Red\_Scale\_Value}) + (\text{Green\_Cycle\_}\% \times \text{Green\_Scale\_Value}) + (\text{Blue\_Cycle\_}\% \times \text{Blue\_Scale\_Value})$$

Where:

Red\_Cycle\_%, Green\_Cycle\_%, and Blue\_Cycle\_%, represent the percentage of the frame time that Red, Green, and Blue are displayed (respectively) to achieve the desired white point.

For example, assume that the red, green and blue color cycle times are 50%, 20%, and 30% respectively (in order to achieve the desired white point), then the Landed Duty Cycle for various combinations of red, green, blue color intensities would be as shown in [Table 4](#).



**Table 4. Example Landed Duty Cycle for Full-Color**

| Red Cycle Percentage<br>50% | Green Cycle Percentage<br>20% | Blue Cycle Percentage<br>30% | Landed Duty Cycle |
|-----------------------------|-------------------------------|------------------------------|-------------------|
| Red Scale Value             | Green Scale Value             | Blue Scale Value             |                   |
| 0%                          | 0%                            | 0%                           | 0/100             |
| 100%                        | 0%                            | 0%                           | 50/50             |
| 0%                          | 100%                          | 0%                           | 20/80             |
| 0%                          | 0%                            | 100%                         | 30/70             |
| 12%                         | 0%                            | 0%                           | 6/94              |
| 0%                          | 35%                           | 0%                           | 7/93              |
| 0%                          | 0%                            | 60%                          | 18/82             |
| 100%                        | 100%                          | 0%                           | 70/30             |
| 0%                          | 100%                          | 100%                         | 50/50             |
| 100%                        | 0%                            | 100%                         | 80/20             |
| 12%                         | 35%                           | 0%                           | 13/87             |
| 0%                          | 35%                           | 60%                          | 25/75             |
| 12%                         | 0%                            | 60%                          | 24/76             |
| 100%                        | 100%                          | 100%                         | 100/0             |

## 8 Application and Implementation

### NOTE

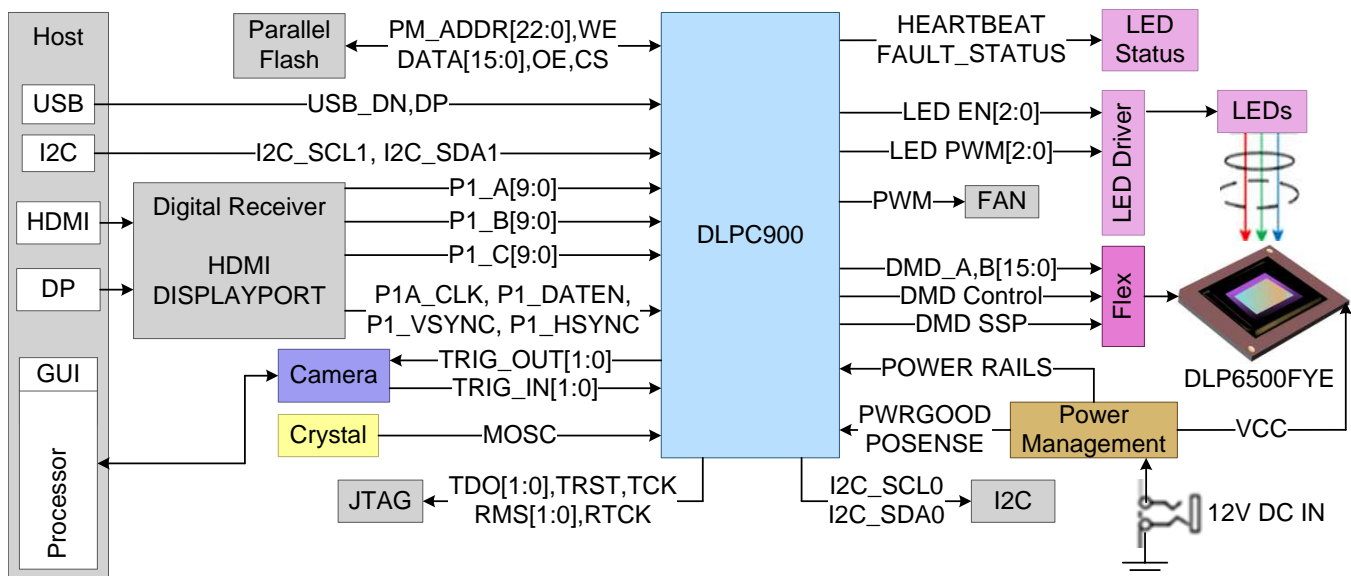
Information in the following applications sections is not part of the TI component specification, and TI does not warrant its accuracy or completeness. TI's customers are responsible for determining suitability of components for their purposes. Customers should validate and test their design implementation to confirm system functionality.

### 8.1 Application Information

The DLP6500FYE along with the DLPC900 controller provides a solution for many applications including structured light and video projection. The DMD is a spatial light modulator, which reflects incoming light from an illumination source to one of two directions, with the primary direction being into a projection or collection optic. Each application is derived primarily from the optical architecture of the system and the format of the data coming into the DLPC900. Applications of interest include machine vision and 3D printing.

### 8.2 Typical Application

A typical embedded system application using the DLPC900 controller and a DLP6500FYE is shown in Figure 16. In this configuration, the DLPC900 controller supports a 24-bit parallel RGB input, typical of LCD interfaces, from an external source or processor. This system configuration supports still and motion video sources plus sequential pattern mode. Refer to Related Documents for the DLPC900 digital controller data sheet.



**Figure 16. Typical Application Schematic**

#### 8.2.1 Design Requirements

Detailed design requirements are located in the DLPC900 digital controller data sheet. Refer to Related Documents.

#### 8.2.2 Detailed Design Procedure

See the reference design schematic for connecting together the DLPC900 display controller and the DLP6500 DMD. An example board layout is included in the reference design data base. Layout guidelines should be followed for reliability.

## 9 Power Supply Recommendations

### 9.1 DMD Power Supply Requirements

The following power supplies are all required to operate the DMD: VCC, VCCI, VOFFSET, VBIAS, and VRESET. VSS must also be connected. DMD power-up and power-down sequencing is strictly controlled by the DLPC900 device.

#### CAUTION

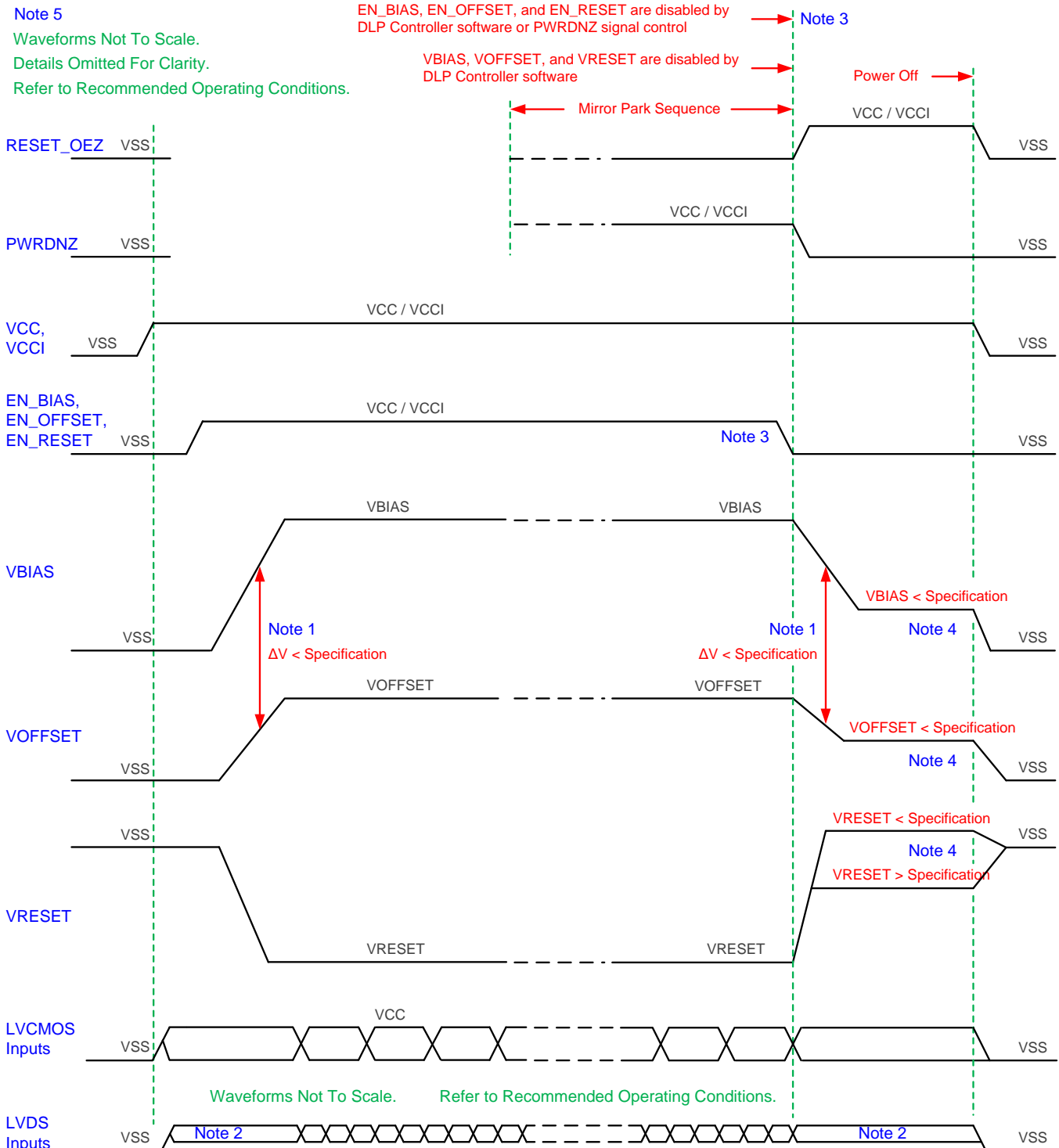
For reliable operation of the DMD, the following power supply sequencing requirements must be followed. Failure to adhere to the prescribed power-up and power-down procedures may affect device reliability. VCC, VCCI, VOFFSET, VBIAS, and VRESET power supplies have to be coordinated during power-up and power-down operations. VSS must also be connected. Failure to meet any of the below requirements will result in a significant reduction in the DMD's reliability and lifetime. Refer to [Figure 17](#).

### 9.2 DMD Power Supply Power-Up Procedure

- During power-up, VCC and VCCI must always start and settle before VOFFSET, VBIAS, and VRESET voltages are applied to the DMD.
- During power-up, it is a strict requirement that the delta between VBIAS and VOFFSET must be within the specified limit shown in [Recommended Operating Conditions](#) s. During power-up, VBIAS does not have to start after VOFFSET.
- During power-up, there is no requirement for the relative timing of VRESET with respect to VOFFSET and VBIAS.
- Power supply slew rates during power-up are flexible, provided that the transient voltage levels follow the requirements listed in [Absolute Maximum Ratings](#) , in [Recommended Operating Conditions](#) , and in [DMD Power Supply Sequencing Requirements](#) .
- During power-up, LVCMOS input pins shall not be driven high until after VCC and VCCI have settled at operating voltages listed in [Recommended Operating Conditions](#) .

### 9.3 DMD Power Supply Power-Down Procedure

- During power-down, VCC and VCCI must be supplied until after VBIAS, VRESET, and VOFFSET are discharged to within the specified limit of ground. Refer to [Table 5](#).
- During power-down, it is a strict requirement that the delta between VBIAS and VOFFSET must be within the specified limit shown in [Recommended Operating Conditions](#) . During power-down, it is not mandatory to stop driving VBIAS prior to VOFFSET.
- During power-down, there is no requirement for the relative timing of VRESET with respect to VOFFSET and VBIAS.
- Power supply slew rates during power-down are flexible, provided that the transient voltage levels follow the requirements listed in [Absolute Maximum Ratings](#) , in [Recommended Operating Conditions](#) , and in [Figure 17](#).
- During power-down, LVCMOS input pins must be less than specified in [Recommended Operating Conditions](#) .

**DMD Power Supply Power-Down Procedure (continued)**

**Figure 17. DMD Power Supply Sequencing Requirements**

1. To prevent excess current, the supply voltage delta  $|V_{BIAS} - V_{OFFSET}|$  must be less than specified in [Recommended Operating Conditions](#). OEMs may find that the most reliable way to ensure this is to power VOFFSET prior to VBIAS during power-up and to remove VBIAS prior to VOFFSET during power-down.
2. LVDS signals are less than the input differential voltage (VID) maximum specified in [Recommended](#)

## DMD Power Supply Power-Down Procedure (continued)

*Operating Conditions* . During power-down, LVDS signals are less than the high level input voltage (VIH) maximum specified in *Recommended Operating Conditions* .

3. When system power is interrupted, the DLP controller (DLPC900) initiates a hardware power-down that activates PWRDNZ and disables VBIAS, VRESET and VOFFSET after the micromirror park sequence. Software power-down disables VBIAS, VRESET, and VOFFSET after the micromirror park sequence through software control. For either case, enable signals EN\_BIAS, EN\_OFFSET, and EN\_RESET are used to disable VBIAS, VOFFSET, and VRESET, respectfully.
4. Refer to [Table 5](#).
5. Figure not to scale. Details have been omitted for clarity. Refer to *Recommended Operating Conditions* .

**Table 5. DMD Power-Down Sequence Requirements**

| PARAMETER |   | MIN  | MAX | UNIT |
|-----------|---|------|-----|------|
| VBIAS     | Supply voltage level during power-down sequence |      | 4.0 | V    |
| VOFFSET   |   |      | 4.0 | V    |
| VRESET    |   | –4.0 | 0.5 | V    |

## 10 Layout

### 10.1 Layout Guidelines

The DLP6500FYE along with one DLPC900 controller provides a solution for many applications including structured light and video projection. This section provides layout guidelines for the DLP6500FYE.

#### 10.1.1 General PCB Recommendations

The PCB shall be designed to IPC2221 and IPC2222, Class 2, Type Z, at level B producibility and built to IPC6011 and IPC6012, class 2. The PCB board thickness to be 0.062 inches +/- 10%, using standard FR-4 material, and applies after all lamination and plating processes, measured from copper to copper.

Two-ounce copper planes are recommended in the PCB design in order to achieve needed thermal connectivity. Refer to Related Documents for the DLPC900 Digital Controller Data Sheet for related information on the DMD Interface Considerations.

High-speed interface waveform quality and timing on the DLPC900 controller (that is, the LVDS DMD interface) is dependent on the following factors:

- Total length of the interconnect system
- Spacing between traces
- Characteristic impedance
- Etch losses
- How well matched the lengths are across the interface

Thus, ensuring positive timing margin requires attention to many factors.

As an example, DMD interface system timing margin can be calculated as follows:

- Setup Margin = (controller output setup) – (DMD input setup) – (PCB routing mismatch) – (PCB SI degradation)
- Hold-time Margin = (controller output hold) – (DMD input hold) – (PCB routing mismatch) – (PCB SI degradation)

The PCB SI degradation is the signal integrity degradation due to PCB affects which includes such things as simultaneously switching output (SSO) noise, crosstalk, and inter-symbol-interference (ISI) noise.

DLPC900 I/O timing parameters can be found in DLPC900 Digital Controller Data Sheet. Similarly, PCB routing mismatch can be easily budgeted and met via controlled PCB routing. However, PCB SI degradation is not as easy to determine.

In an attempt to minimize the signal integrity analysis that would otherwise be required, the following PCB design guidelines provide a reference of an interconnect system that satisfies both waveform quality and timing requirements (accounting for both PCB routing mismatch and PCB SI degradation). Deviation from these recommendations may work, but should be confirmed with PCB signal integrity analysis or lab measurements.

### 10.2 Layout Example

#### 10.2.1 Board Stack and Impedance Requirements

Refer to [Figure 18](#) for guidance on the parameters.

##### PCB design:

|                                |                             |
|--------------------------------|-----------------------------|
| Configuration:                 | Asymmetric dual stripline   |
| Etch thickness (T):            | 1.0-oz copper (1.2 mil)     |
| Flex etch thickness (T):       | 0.5-oz copper (0.6 mil)     |
| Single-ended signal impedance: | 50 $\Omega$ ( $\pm 10\%$ )  |
| Differential signal impedance: | 100 $\Omega$ ( $\pm 10\%$ ) |

## Layout Example (continued)

### PCB stack-up:

Reference plane 1 is assumed to be a ground plane for proper return path.

Reference plane 2 is assumed to be the I/O power plane or ground.

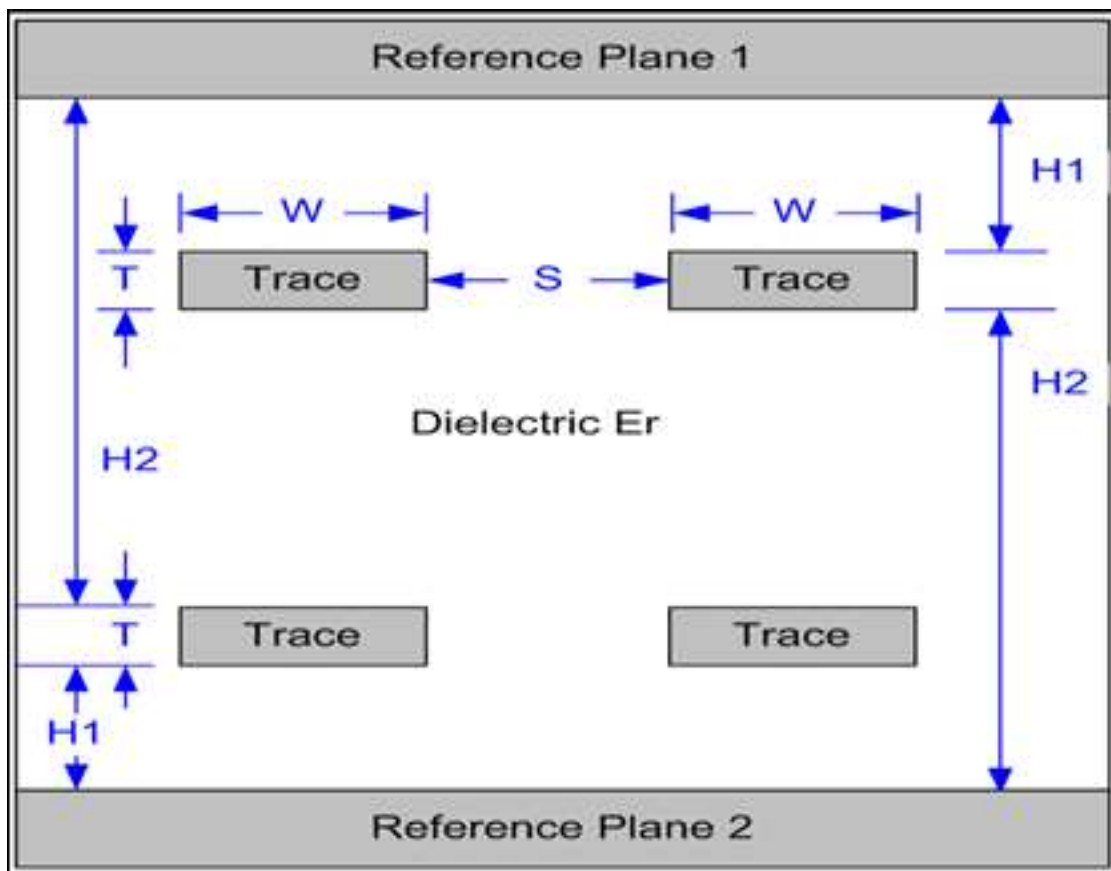
Dielectric FR4, (Er): 4.2 (nominal)

Signal trace distance to reference plane 1 (H1): 5.0 mil (nominal)

(H1):

Signal trace distance to reference plane 2 (H2): 34.2 mil (nominal)

(H2):



**Figure 18. PCB Stack Geometries**

**Table 6. General PCB Routing (Applies to All Corresponding PCB Signals)**

| PARAMETER      | APPLICATION                  | SINGLE-ENDED SIGNALS | DIFFERENTIAL PAIRS | UNIT        |
|----------------|------------------------------|----------------------|--------------------|-------------|
| Line width (W) | Escape routing in ball field | 4<br>(0.1)           | 4<br>(0.1)         | mil<br>(mm) |
|                | PCB etch data or control     | 7<br>(0.18)          | 4.25<br>(0.11)     | mil<br>(mm) |
|                | PCB etch clocks              | 7<br>(0.18)          | 4.25<br>(0.11)     | mil<br>(mm) |

**Layout Example (continued)**
**Table 6. General PCB Routing (Applies to All Corresponding PCB Signals) (continued)**

| PARAMETER  | APPLICATION                  | SINGLE-ENDED SIGNALS | DIFFERENTIAL PAIRS           | UNIT        |
|--|------------------------------|----------------------|------------------------------|-------------|
| Differential signal pair spacing (S)             | PCB etch data or control     | N/A                  | 5.75 <sup>(1)</sup><br>–0.15 | mil<br>(mm) |
|  | PCB etch clocks              | N/A                  | 5.75 <sup>(1)</sup><br>–0.15 | mil<br>(mm) |
| Minimum differential pair-to-pair spacing (S)    | PCB etch data or control     | N/A                  | 20<br>(0.51)                 | mil<br>(mm) |
|  | PCB etch clocks              | N/A                  | 20<br>(0.51)                 | mil<br>(mm) |
|  | Escape routing in ball field | 4<br>(0.1)           | 4<br>(0.1)                   | mil<br>(mm) |
| Minimum line spacing to other signals (S)        | PCB etch data or control     | 10<br>(0.25)         | 20<br>(0.51)                 | mil<br>(mm) |
|  | PCB etch clocks              | 20<br>(0.51)         | 20<br>(0.51)                 | mil<br>(mm) |
| Maximum differential pair P-to-N length mismatch | Total data                   | N/A                  | 12<br>0.3                    | mil<br>(mm) |
|  | Total data                   | N/A                  | 12<br>0.3                    | mil<br>(mm) |

(1) Spacing may vary to maintain differential impedance requirements

**Table 7. DMD Interface Specific Routing**

| SIGNAL GROUP LENGTH MATCHING |   |                  |                   |             |
|------------------------------|---|------------------|-------------------|-------------|
| INTERFACE                    | SIGNAL GROUP                                  | REFERENCE SIGNAL | MAX MISMATCH      | UNIT        |
| DMD (LVDS)                   | SCTRL_AN / SCTRL_AP<br>D_AP(15:0)/ D_AN(15:0) | DCKA_P/ DCKA_N   | ± 150<br>(± 3.81) | mil<br>(mm) |
| DMD (LVDS)                   | SCTRL_BN/ SCTRL_BP<br>D_BP(15:0)/ D_BN(15:0)  | DCKB_P/ DCKB_N   | ± 150<br>(± 3.81) | mil<br>(mm) |

Number of layer changes:

- Single-ended signals: Minimize
- Differential signals: Individual differential pairs can be routed on different layers but the signals of a given pair should not change layers.

**Table 8. DMD Signal Routing Length<sup>(1)</sup>**

| BUS        | MIN | MAX | UNIT |
|------------|-----|-----|------|
| DMD (LVDS) | 50  | 375 | mm   |

(1) Max signal routing length includes escape routing.

Stubs: Stubs should be avoided.

Termination Requirements: DMD interface: None – The DMD receiver is differentially terminated to 100 Ω internally.

Connector (DMD-LVDS interface bus only):

High-speed connectors that meet the following requirements should be used:

- Differential crosstalk: < 5%
- Differential impedance: 75 to 125 Ω



Routing requirements for right-angle connectors: When using right-angle connectors, P-N pairs should be routed in the same row to minimize delay mismatch. When using right-angle connectors, propagation delay difference for each row should be accounted for on associated PCB etch lengths. Voltage or low frequency signals should be routed on the outer layers. Signal trace corners shall be no sharper than 45 degrees. Adjacent signal layers shall have the predominant traces routed orthogonal to each other.

These guidelines will produce a maximum PCB routing mismatch of 4.41 mm (0.174 inch) or approximately 30.4 ps, assuming 175 ps/inch FR4 propagation delay.

These PCB routing guidelines will result in approximately 25-ps system setup margin and 25-ps system hold margin for the DMD interface after accounting for signal integrity degradation as well as routing mismatch.

Both the DLPC900 output timing parameters and the DLP6500FYE DMD input timing parameters include timing budget to account for their respective internal package routing skew.

### 10.2.1.1 Power Planes

Signal routing is NOT allowed on the power and ground planes. All device pin and via connections to this plane shall use a thermal relief with a minimum of four spokes. The power plane shall clear the edge of the PCB by 0.2".

Prior to routing, vias connecting all digital ground layers (GND) should be placed around the edge of the rigid PWB regions 0.025" from the board edges with a 0.100" spacing. It is also desirable to have all internal digital ground (GND) planes connected together in as many places as possible. If possible, all internal ground planes should be connected together with a minimum distance between connections of 0.5". Extra vias are not required if there are sufficient ground vias due to normal ground connections of devices. NOTE: All signal routing and signal vias should be inside the perimeter ring of ground vias.

Power and Ground pins of each component shall be connected to the power and ground planes with one via for each pin. Trace lengths for component power and ground pins should be minimized (ideally, less than 0.100"). Unused or spare device pins that are connected to power or ground may be connected together with a single via to power or ground. Ground plane slots are NOT allowed.

Route VOFFSET, VBIAS, and VRESET as a wide trace >20mils (wider if space allows) with 20 mils spacing.

### 10.2.1.2 LVDS Signals

The LVDS signals shall be first. Each pair of differential signals must be routed together at a constant separation such that constant differential impedance (as in section [Board Stack and Impedance Requirements](#) ) is maintained throughout the length. Avoid sharp turns and layer switching while keeping lengths to a minimum. The distance from one pair of differential signals to another shall be at least 2 times the distance within the pair.

### 10.2.1.3 Critical Signals

The critical signals on the board must be hand routed in the order specified below. In case of length matching requirements, the longer signals should be routed in a serpentine fashion, keeping the number of turns to a minimum and the turn angles no sharper than 45 degrees. Avoid routing long trace all around the PCB.

**Table 9. Timing Critical Signals**

| GROUP | SIGNAL   | CONSTRAINTS  | ROUTING LAYERS  |
|-------|--|--|---|
| 1     | D_AP(0:15), D_AN(0:15), DCLK_AP, DCLK_AN, SCTRL_AN, SCTRL_AP, D_BP(0:15), D_BN(0:15), DCLK_BP, DCLK_BN, SCTRL_BN, SCTRL_BP | Refer to <a href="#">Table 6</a> and <a href="#">Table 7</a> | Internal signal layers. Avoid layer switching when routing these signals. |
| 2     | RESET_ADDR_(0:3), RESET_MODE_(0:1), RESET_OEZ, RESET_SEL_(0:1), RESET_STROBE, RESET_IRQZ.                                  |  | Internal signal layers. Top and bottom as required.                       |
| 3     | SCP_CLK, SCP_DO, SCP_DI, SCP_DMD_CSZ.  |  | Any   |
| 4     | Others   | No matching/length requirement                               | Any   |

#### **10.2.1.4 Device Placement**

Unless otherwise specified, all major components should be placed on top layer. Small components such as ceramic, non-polarized capacitors, resistors and resistor networks can be placed on bottom layer. All high frequency de-coupling capacitors for the ICs shall be placed near the parts. Distribute the capacitors evenly around the IC and locate them as close to the device's power pins as possible (preferably with no vias). In the case where an IC has multiple de-coupling capacitors with different values, alternate the values of those that are side by side as much as possible and place the smaller value capacitor closer to the device.

#### **10.2.1.5 Device Orientation**

It is desirable to have all polarized capacitors oriented with their positive terminals in the same direction. If polarized capacitors are oriented both horizontally and vertically, then all horizontal capacitors should be oriented with the "+" terminal the same direction and likewise for the vertically oriented ones.

#### **10.2.1.6 Fiducials**

Fiducials for automatic component insertion should be placed on the board according to the following guidelines or on recommendation from manufacturer:

- Fiducials for optical auto insertion alignment shall be placed on three corners of both sides of the PWB.
- Fiducials shall also be placed in the center of the land patterns for fine pitch components (lead spacing <0.05").
- Fiducials should be 0.050 inch copper with 0.100 inch cutout (antipad).

## 11 器件文档支持

### 11.1 器件支持

#### 11.1.1 器件命名规则

表 10. 封装具体信息

| 封装类型 | 引脚  | 连接器 |
|------|-----|-----|
| FYE  | 350 | PGA |

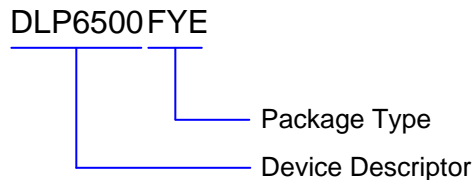


图 19. 部件号说明

#### 11.1.2 器件标记

器件标记将包括可读信息和一个二维矩阵码。图 20 中显示了可读信息。二维矩阵码是一个字母数字字符串，其中包含 DMD 部件号、序列号的第 1 部分和序列号的第 2 部分。DMD 序列号（第 1 部分）的首字符为制造年份。DMD 序列号（第 1 部分）的第二个字符为制造月份。DMD 序列号（第 2 部分）的最后一个字符为偏置电压二进制字母。

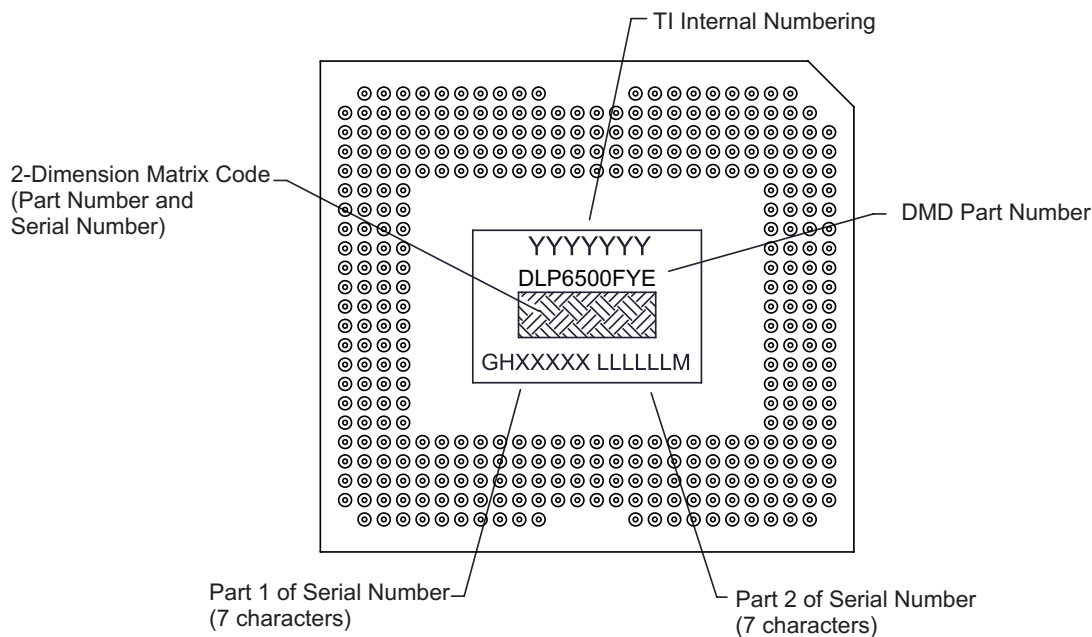


图 20. DMD 标记

## 11.2 文档支持

### 11.2.1 相关文档

以下文档包含关于使用 DLP6500 器件的更多信息。

表 11. 相关文档

| 文档               |                         |
|------------------|-------------------------|
| DLPC900 数字控制器数据表 | <a href="#">DLPS037</a> |
| DLPC900 软件编程人员指南 | <a href="#">DLPU018</a> |

## 11.3 商标

DLP is a trademark of Texas Instruments.

All other trademarks are the property of their respective owners.

## 11.4 静电放电警告



这些装置包含有限的内置 ESD 保护。存储或装卸时，应将导线一起截短或将装置放置于导电泡棉中，以防止 MOS 门极遭受静电损伤。

## 11.5 术语表

[SLYZ022](#) — TI 术语表。

这份术语表列出并解释术语、首字母缩略词和定义。

## 12 机械封装和可订购信息

以下页中包括机械封装和可订购信息。 这些信息是针对指定器件可提供的最新数据。 这些数据会在无通知且不对本文档进行修订的情况下发生改变。 欲获得该数据表的浏览器版本，请查阅左侧的导航栏。

## 重要声明

德州仪器(TI) 及其下属子公司有权根据 JESD46 最新标准, 对所提供的产品和服务进行更正、修改、增强、改进或其它更改, 并有权根据 JESD48 最新标准中止提供任何产品和服务。客户在下订单前应获取最新的相关信息, 并验证这些信息是否完整且是最新的。所有产品的销售都遵循在订单确认时所提供的TI 销售条款与条件。

TI 保证其所销售的组件的性能符合产品销售时 TI 半导体产品销售条件与条款的适用规范。仅在 TI 保证的范围内, 且 TI 认为 有必要时才会使用测试或其它质量控制技术。除非适用法律做出了硬性规定, 否则没有必要对每种组件的所有参数进行测试。

TI 对应用帮助或客户产品设计不承担任何义务。客户应对其使用 TI 组件的产品和应用自行负责。为尽量减小与客户产品和应用相关的风险, 客户应提供充分的设计与操作安全措施。

TI 不对任何 TI 专利权、版权、屏蔽作品权或其它与使用了 TI 组件或服务的组合设备、机器或流程相关的 TI 知识产权中授予 的直接或隐含权限作出任何保证或解释。TI 所发布的与第三方产品或服务有关的信息, 不能构成从 TI 获得使用这些产品或服务 的许可、授权、或认可。使用此类信息可能需要获得第三方的专利权或其它知识产权方面的许可, 或是 TI 的专利权或其它 知识产权方面的许可。

对于 TI 的产品手册或数据表中 TI 信息的重要部分, 仅在没有对内容进行任何篡改且带有相关授权、条件、限制和声明的情况 下才允许进行复制。TI 对此类篡改过的文件不承担任何责任或义务。复制第三方的信息可能需要服从额外的限制条件。

在转售 TI 组件或服务时, 如果对该组件或服务参数的陈述与 TI 标明的参数相比存在差异或虚假成分, 则会失去相关 TI 组件 或服务的所有明示或暗示授权, 且这是不正当的、欺诈性商业行为。TI 对任何此类虚假陈述均不承担任何责任或义务。

客户认可并同意, 尽管任何应用相关信息或支持仍可能由 TI 提供, 但他们将独力负责满足与其产品及其在应用中使用的 TI 产品 相关的所有法律、法规和安全相关要求。客户声明并同意, 他们具备制定与实施安全措施所需的全部专业技术和知识, 可预见 故障的危险后果、监测故障及其后果、降低有可能造成人身伤害的故障的发生机率并采取适当的补救措施。客户将全额赔偿因 在此类安全关键应用中使用任何 TI 组件而对 TI 及其代理造成的任何损失。

在某些场合中, 为了推进安全相关应用有可能对 TI 组件进行特别的促销。TI 的目标是利用此类组件帮助客户设计和创立其特 有的可满足适用的功能安全性标准和要求的终端产品解决方案。尽管如此, 此类组件仍然服从这些条款。

TI 组件未获得用于 FDA Class III (或类似的生命攸关医疗设备) 的授权许可, 除非各方授权官员已经达成了专门管控此类使 用的特别协议。

只有那些 TI 特别注明属于军用等级或“增强型塑料”的 TI 组件才是设计或专门用于军事/航空应用或环境的。购买者认可并同 意, 对并非指定面向军事或航空航天用途的 TI 组件进行军事或航空航天方面的应用, 其风险由客户单独承担, 并且由客户独 力负责满足与此类使用相关的所有法律和法规要求。

TI 已明确指定符合 ISO/TS16949 要求的产品, 这些产品主要用于汽车。在任何情况下, 因使用非指定产品而无法达到 ISO/TS16949 要求, TI 不承担任何责任。

|               | 产品   |              | 应用   |
|---------------|--|--------------|--|
| 数字音频          | <a href="http://www.ti.com.cn/audio">www.ti.com.cn/audio</a>                               | 通信与电信        | <a href="http://www.ti.com.cn/telecom">www.ti.com.cn/telecom</a>             |
| 放大器和线性器件      | <a href="http://www.ti.com.cn/amplifiers">www.ti.com.cn/amplifiers</a>                     | 计算机及周边       | <a href="http://www.ti.com.cn/computer">www.ti.com.cn/computer</a>           |
| 数据转换器         | <a href="http://www.ti.com.cn/dataconverters">www.ti.com.cn/dataconverters</a>             | 消费电子         | <a href="http://www.ti.com.cn/consumer-apps">www.ti.com.cn/consumer-apps</a> |
| DLP® 产品       | <a href="http://www.dlp.com">www.dlp.com</a>   | 能源           | <a href="http://www.ti.com.cn/energy">www.ti.com.cn/energy</a>               |
| DSP - 数字信号处理器 | <a href="http://www.ti.com.cn/dsp">www.ti.com.cn/dsp</a>                                   | 工业应用         | <a href="http://www.ti.com.cn/industrial">www.ti.com.cn/industrial</a>       |
| 时钟和计时器        | <a href="http://www.ti.com.cn/clockandtimers">www.ti.com.cn/clockandtimers</a>             | 医疗电子         | <a href="http://www.ti.com.cn/medical">www.ti.com.cn/medical</a>             |
| 接口            | <a href="http://www.ti.com.cn/interface">www.ti.com.cn/interface</a>                       | 安防应用         | <a href="http://www.ti.com.cn/security">www.ti.com.cn/security</a>           |
| 逻辑            | <a href="http://www.ti.com.cn/logic">www.ti.com.cn/logic</a>                               | 汽车电子         | <a href="http://www.ti.com.cn/automotive">www.ti.com.cn/automotive</a>       |
| 电源管理          | <a href="http://www.ti.com.cn/power">www.ti.com.cn/power</a>                               | 视频和影像        | <a href="http://www.ti.com.cn/video">www.ti.com.cn/video</a>                 |
| 微控制器 (MCU)    | <a href="http://www.ti.com.cn/microcontrollers">www.ti.com.cn/microcontrollers</a>         |              |  |
| RFID 系统       | <a href="http://www.ti.com.cn/rfidsys">www.ti.com.cn/rfidsys</a>                           |              |  |
| OMAP应用处理器     | <a href="http://www.ti.com.cn/omap">www.ti.com.cn/omap</a>                                 |              |  |
| 无线连通性         | <a href="http://www.ti.com.cn/wirelessconnectivity">www.ti.com.cn/wirelessconnectivity</a> | 德州仪器在线技术支持社区 | <a href="http://www.deyisupport.com">www.deyisupport.com</a>                 |

邮寄地址: 上海市浦东新区世纪大道1568号, 中建大厦32楼邮政编码: 200122  
Copyright © 2014, 德州仪器半导体技术(上海)有限公司

## PACKAGING INFORMATION

| Orderable Device | Status<br>(1) | Package Type | Package<br>Drawing | Pins | Package<br>Qty | Eco Plan<br>(2)            | Lead/Ball Finish<br>(6) | MSL Peak Temp<br>(3) | Op Temp (°C) | Device Marking<br>(4/5) | Samples                 |
|------------------|---------------|--------------|--------------------|------|----------------|----------------------------|-------------------------|----------------------|--------------|-------------------------|-------------------------|
| DLP6500FYE       | ACTIVE        | CPGA         | FYE                | 350  | 1              | Green (RoHS<br>& no Sb/Br) | PD NIPDAU               | Level-1-NC-NC        |              |                         | <a href="#">Samples</a> |

(1) The marketing status values are defined as follows:

**ACTIVE:** Product device recommended for new designs.

**LIFEBUY:** TI has announced that the device will be discontinued, and a lifetime-buy period is in effect.

**NRND:** Not recommended for new designs. Device is in production to support existing customers, but TI does not recommend using this part in a new design.

**PREVIEW:** Device has been announced but is not in production. Samples may or may not be available.

**OBSOLETE:** TI has discontinued the production of the device.

(2) Eco Plan - The planned eco-friendly classification: Pb-Free (RoHS), Pb-Free (RoHS Exempt), or Green (RoHS & no Sb/Br) - please check <http://www.ti.com/productcontent> for the latest availability information and additional product content details.

**TBD:** The Pb-Free/Green conversion plan has not been defined.

**Pb-Free (RoHS):** TI's terms "Lead-Free" or "Pb-Free" mean semiconductor products that are compatible with the current RoHS requirements for all 6 substances, including the requirement that lead not exceed 0.1% by weight in homogeneous materials. Where designed to be soldered at high temperatures, TI Pb-Free products are suitable for use in specified lead-free processes.

**Pb-Free (RoHS Exempt):** This component has a RoHS exemption for either 1) lead-based flip-chip solder bumps used between the die and package, or 2) lead-based die adhesive used between the die and leadframe. The component is otherwise considered Pb-Free (RoHS compatible) as defined above.

**Green (RoHS & no Sb/Br):** TI defines "Green" to mean Pb-Free (RoHS compatible), and free of Bromine (Br) and Antimony (Sb) based flame retardants (Br or Sb do not exceed 0.1% by weight in homogeneous material)

(3) MSL, Peak Temp. - The Moisture Sensitivity Level rating according to the JEDEC industry standard classifications, and peak solder temperature.

(4) There may be additional marking, which relates to the logo, the lot trace code information, or the environmental category on the device.

(5) Multiple Device Markings will be inside parentheses. Only one Device Marking contained in parentheses and separated by a "~" will appear on a device. If a line is indented then it is a continuation of the previous line and the two combined represent the entire Device Marking for that device.

(6) Lead/Ball Finish - Orderable Devices may have multiple material finish options. Finish options are separated by a vertical ruled line. Lead/Ball Finish values may wrap to two lines if the finish value exceeds the maximum column width.

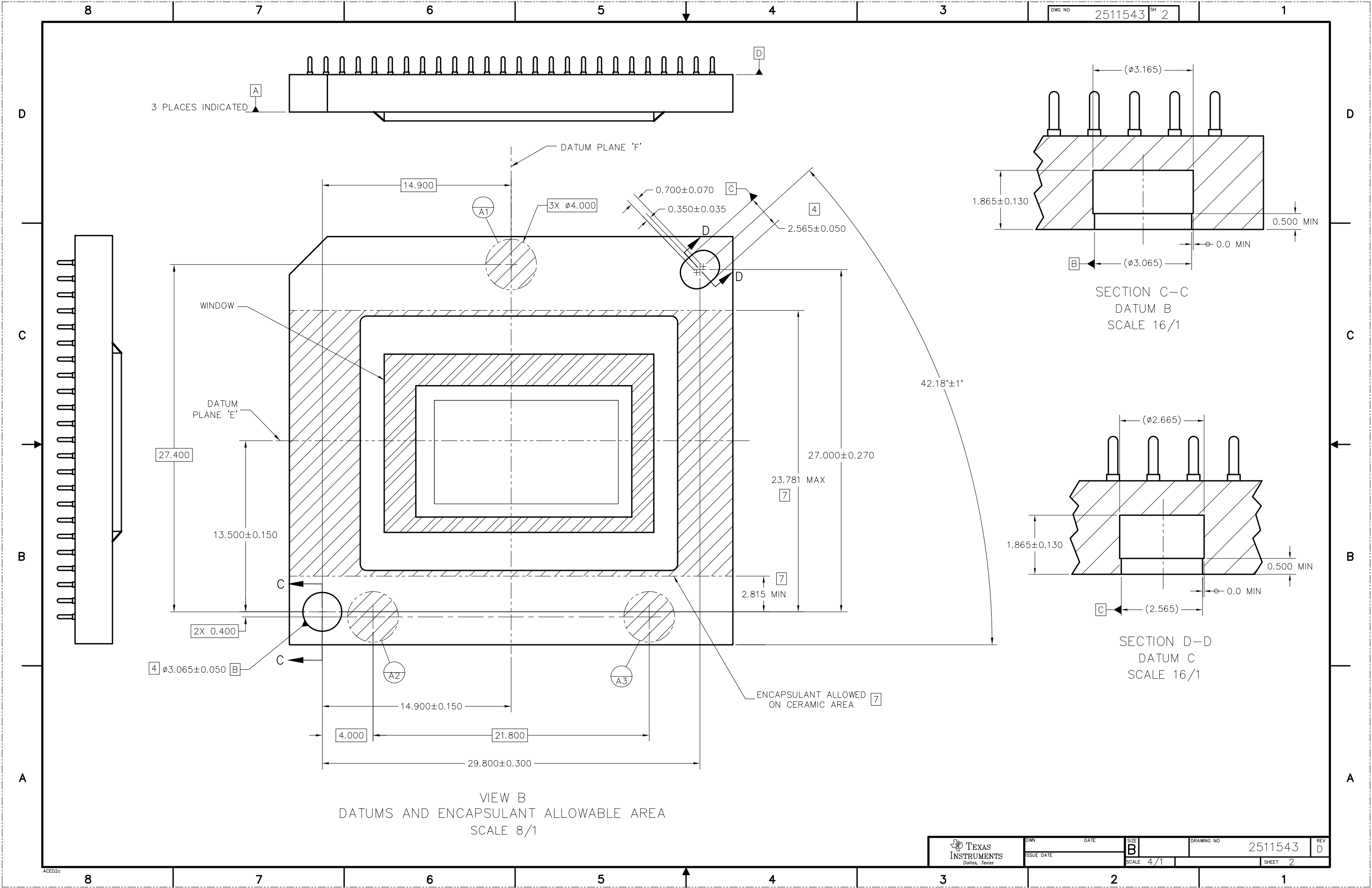
**Important Information and Disclaimer:** The information provided on this page represents TI's knowledge and belief as of the date that it is provided. TI bases its knowledge and belief on information provided by third parties, and makes no representation or warranty as to the accuracy of such information. Efforts are underway to better integrate information from third parties. TI has taken and continues to take reasonable steps to provide representative and accurate information but may not have conducted destructive testing or chemical analysis on incoming materials and chemicals. TI and TI suppliers consider certain information to be proprietary, and thus CAS numbers and other limited information may not be available for release.

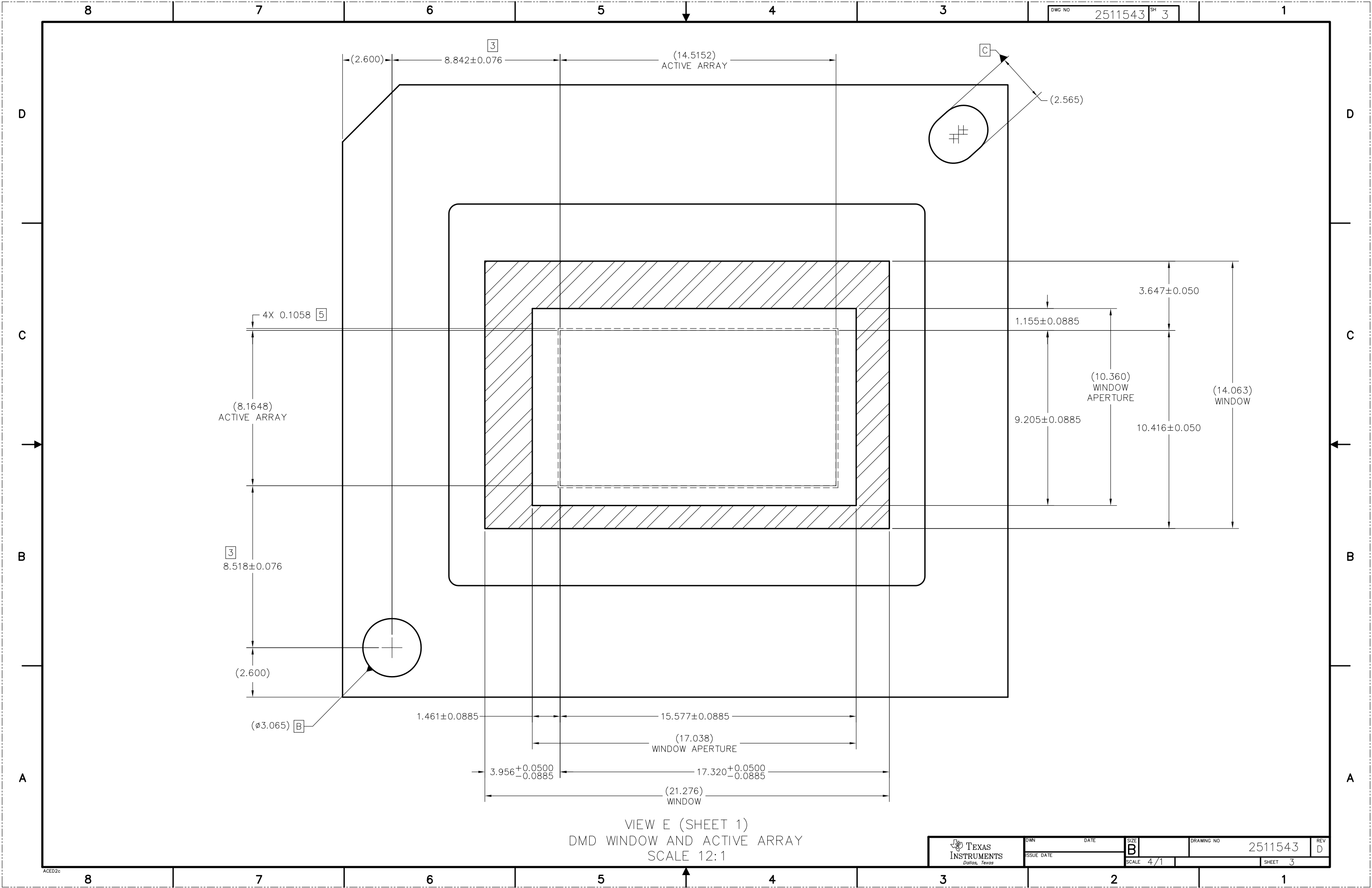
In no event shall TI's liability arising out of such information exceed the total purchase price of the TI part(s) at issue in this document sold by TI to Customer on an annual basis.











8

7

6

5

4

3

DWG NO

2511543

SH

4

1

D

D

C

C

B

B

A

A

3 PLACES INDICATED

A

D

DATUM PLANE 'E'

 $10.000 \pm 0.250$  $11.100 \pm 0.250$ 

SEE DETAIL G

350X  $\phi 0.305 \pm 0.05$   
 $-0.025$  PINS

|              |   |   |   |
|--------------|---|---|---|
| $\phi 0.500$ | D | E | F |
| $\phi 0.250$ | D |   |   |

4 SYMBOLIZATION PAD

423

423

 $(35.000)$  $25 \times 1.270 = 31.750$ 

15.875

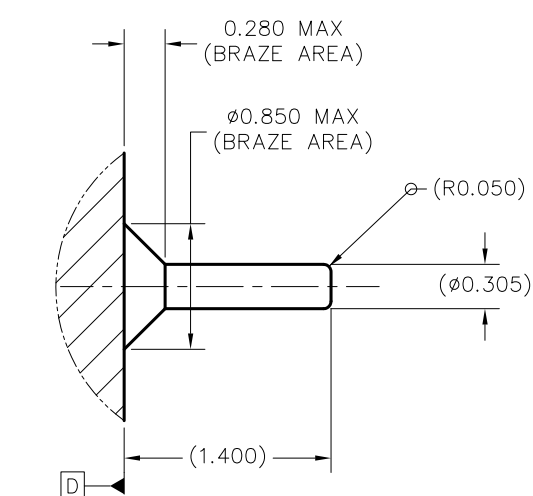
DATUM PLANE 'F'

(PINS A1, A2, A12, A13, A14,  
A15, A26, B1, AA1, AA12, AA13,  
AA14, AA15, AA26 OMITTED)A  
B  
C  
D  
E  
F  
G  
H  
J  
K  
L  
M  
N  
P  
R  
T  
U  
V  
W  
X  
Y  
Z  
AA $22 \times 1.270 = 27.940$ 

13.970

 $(2.130)$  $(32.200)$ 

E

VIEW F-F (SHEET 1)  
PINS AND SYMBOLIZATION PAD  
SCALE 8/1DETAIL G (350 PLACES)  
PIN & BRAZE DIMENSIONS  
SCALE 40/1

DWN DATE

ISSUE DATE

SIZE

B

SCALE 4/1

DRAWING NO

2511543

REV

D

SHEET 4

ACED2c

## 重要声明

德州仪器(TI) 及其下属子公司有权根据 JESD46 最新标准, 对所提供的产品和服务进行更正、修改、增强、改进或其它更改, 并有权根据 JESD48 最新标准中止提供任何产品和服务。客户在下订单前应获取最新的相关信息, 并验证这些信息是否完整且是最新的。所有产品的销售都遵循在订单确认时所提供的TI 销售条款与条件。

TI 保证其所销售的组件的性能符合产品销售时 TI 半导体产品销售条件与条款的适用规范。仅在 TI 保证的范围内, 且 TI 认为 有必要时才会使用测试或其它质量控制技术。除非适用法律做出了硬性规定, 否则没有必要对每种组件的所有参数进行测试。

TI 对应用帮助或客户产品设计不承担任何义务。客户应对其使用 TI 组件的产品和应用自行负责。为尽量减小与客户产品和应用相关的风险, 客户应提供充分的设计与操作安全措施。

TI 不对任何 TI 专利权、版权、屏蔽作品权或其它与使用了 TI 组件或服务的组合设备、机器或流程相关的 TI 知识产权中授予 的直接或隐含权限作出任何保证或解释。TI 所发布的与第三方产品或服务有关的信息, 不能构成从 TI 获得使用这些产品或服务 的许可、授权、或认可。使用此类信息可能需要获得第三方的专利权或其它知识产权方面的许可, 或是 TI 的专利权或其它 知识产权方面的许可。

对于 TI 的产品手册或数据表中 TI 信息的重要部分, 仅在没有对内容进行任何篡改且带有相关授权、条件、限制和声明的情况 下才允许进行复制。TI 对此类篡改过的文件不承担任何责任或义务。复制第三方的信息可能需要服从额外的限制条件。

在转售 TI 组件或服务时, 如果对该组件或服务参数的陈述与 TI 标明的参数相比存在差异或虚假成分, 则会失去相关 TI 组件 或服务的所有明示或暗示授权, 且这是不正当的、欺诈性商业行为。TI 对任何此类虚假陈述均不承担任何责任或义务。

客户认可并同意, 尽管任何应用相关信息或支持仍可能由 TI 提供, 但他们将独力负责满足与其产品及其在应用中 使用 TI 产品 相关的所有法律、法规和安全相关要求。客户声明并同意, 他们具备制定与实施安全措施所需的全部专业技术和知识, 可预见 故障的危险后果、监测故障及其后果、降低有可能造成人身伤害的故障的发生机率并采取适当的补救措施。客户将全额赔偿因 在此类安全关键应用中使用任何 TI 组件而对 TI 及其代理造成的任何损失。

在某些场合中, 为了推进安全相关应用有可能对 TI 组件进行特别的促销。TI 的目标是利用此类组件帮助客户设计和创立其特 有的可满足适用的功能安全性标准 and 要求的终端产品解决方案。尽管如此, 此类组件仍然服从这些条款。

TI 组件未获得用于 FDA Class III (或类似的生命攸关医疗设备) 的授权许可, 除非各方授权官员已经达成了专门管控此类使 用的特别协议。

只有那些 TI 特别注明属于军用等级或“增强型塑料”的 TI 组件才是设计或专门用于军事/航空应用或环境的。购买者认可并同 意, 对并非指定面向军事或航空航天用途的 TI 组件进行军事或航空航天方面的应用, 其风险由客户单独承担, 并且由客户独 力负责满足与此类使用相关的所有法律和法规要求。

TI 已明确指定符合 ISO/TS16949 要求的产品, 这些产品主要用于汽车。在任何情况下, 因使用非指定产品而无法达到 ISO/TS16949 要 求, TI 不承担任何责任。

|               | 产品   |              | 应用   |
|---------------|--|--------------|--|
| 数字音频          | <a href="http://www.ti.com.cn/audio">www.ti.com.cn/audio</a>                               | 通信与电信        | <a href="http://www.ti.com.cn/telecom">www.ti.com.cn/telecom</a>             |
| 放大器和线性器件      | <a href="http://www.ti.com.cn/amplifiers">www.ti.com.cn/amplifiers</a>                     | 计算机及周边       | <a href="http://www.ti.com.cn/computer">www.ti.com.cn/computer</a>           |
| 数据转换器         | <a href="http://www.ti.com.cn/dataconverters">www.ti.com.cn/dataconverters</a>             | 消费电子         | <a href="http://www.ti.com.cn/consumer-apps">www.ti.com.cn/consumer-apps</a> |
| DLP® 产品       | <a href="http://www.dlp.com">www.dlp.com</a>   | 能源           | <a href="http://www.ti.com.cn/energy">www.ti.com.cn/energy</a>               |
| DSP - 数字信号处理器 | <a href="http://www.ti.com.cn/dsp">www.ti.com.cn/dsp</a>                                   | 工业应用         | <a href="http://www.ti.com.cn/industrial">www.ti.com.cn/industrial</a>       |
| 时钟和计时器        | <a href="http://www.ti.com.cn/clockandtimers">www.ti.com.cn/clockandtimers</a>             | 医疗电子         | <a href="http://www.ti.com.cn/medical">www.ti.com.cn/medical</a>             |
| 接口            | <a href="http://www.ti.com.cn/interface">www.ti.com.cn/interface</a>                       | 安防应用         | <a href="http://www.ti.com.cn/security">www.ti.com.cn/security</a>           |
| 逻辑            | <a href="http://www.ti.com.cn/logic">www.ti.com.cn/logic</a>                               | 汽车电子         | <a href="http://www.ti.com.cn/automotive">www.ti.com.cn/automotive</a>       |
| 电源管理          | <a href="http://www.ti.com.cn/power">www.ti.com.cn/power</a>                               | 视频和影像        | <a href="http://www.ti.com.cn/video">www.ti.com.cn/video</a>                 |
| 微控制器 (MCU)    | <a href="http://www.ti.com.cn/microcontrollers">www.ti.com.cn/microcontrollers</a>         |              |  |
| RFID 系统       | <a href="http://www.ti.com.cn/rfidsys">www.ti.com.cn/rfidsys</a>                           |              |  |
| OMAP应用处理器     | <a href="http://www.ti.com.cn/omap">www.ti.com.cn/omap</a>                                 |              |  |
| 无线连通性         | <a href="http://www.ti.com.cn/wirelessconnectivity">www.ti.com.cn/wirelessconnectivity</a> | 德州仪器在线技术支持社区 | <a href="http://www.deyisupport.com">www.deyisupport.com</a>                 |

邮寄地址: 上海市浦东新区世纪大道1568号, 中建大厦32楼邮政编码: 200122  
Copyright © 2014, 德州仪器半导体技术(上海)有限公司